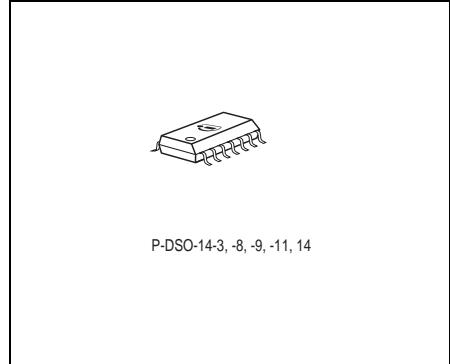


## Low Drop Voltage Regulator

**TLE 7273**

### Features

- Output voltage 5 V, 3.3 V or 2.6 V
- Output voltage tolerance  $\pm 2\%$  up to  $I_Q=180\text{mA}$
- Ultra low quiescent current consumption  $< 35 \mu\text{A}$
- Inhibit function
- Very low dropout voltage
- Reset with adjustable power-on delay
- Window watchdog with current dependent deactivation
- Output protected against short circuit
- Wide operation range: up to 45 V
- Wide temperature range: -40 °C to 150 °C
- Overtemperature Shutdown



P-DSO-14-3, -8, -9, -11, 14

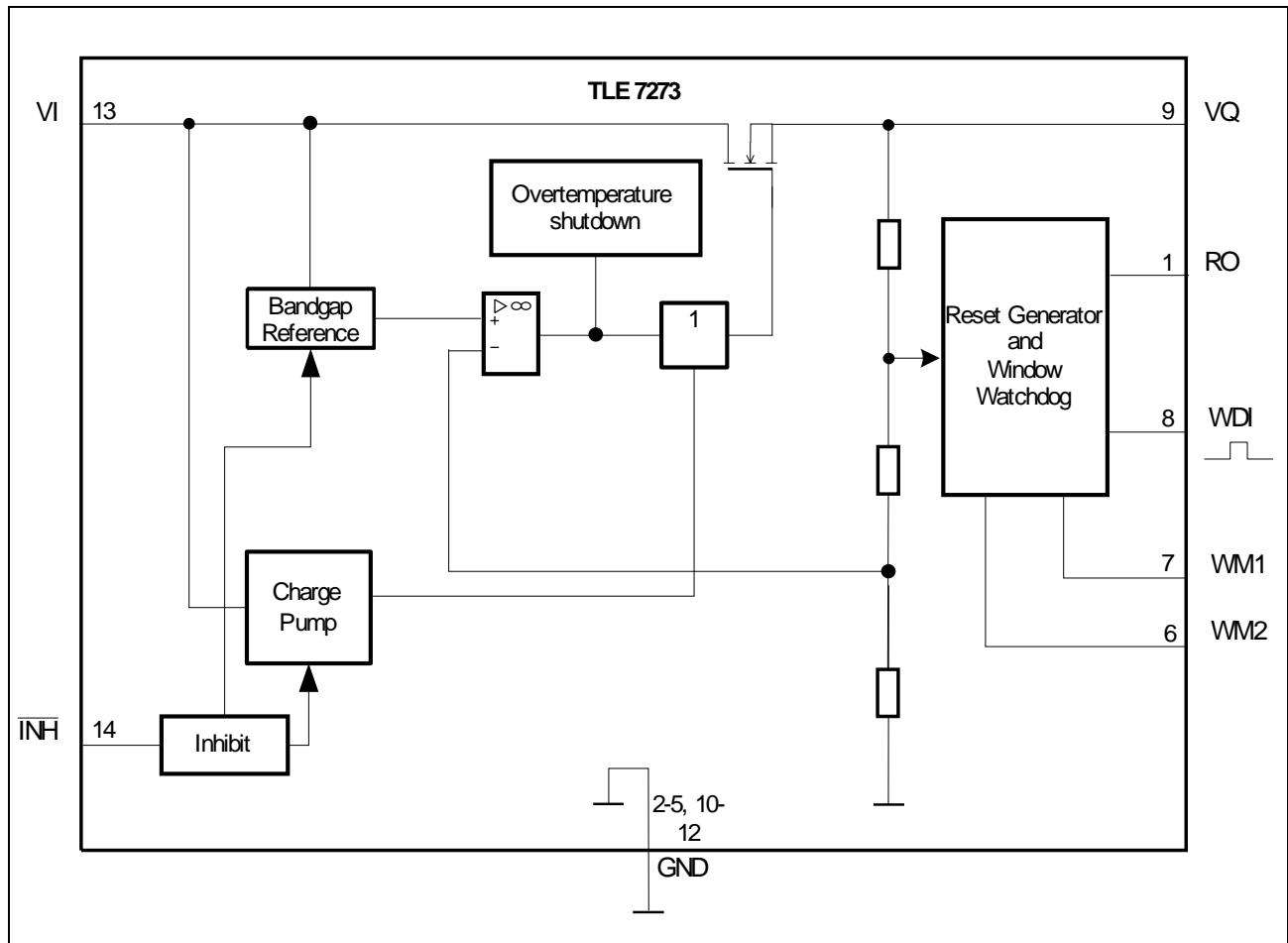
### Functional Description

The TLE 7273 is a monolithic integrated voltage regulator with integrated window watchdog and reset dedicated for microcontroller supplies under harsh automotive environment conditions.

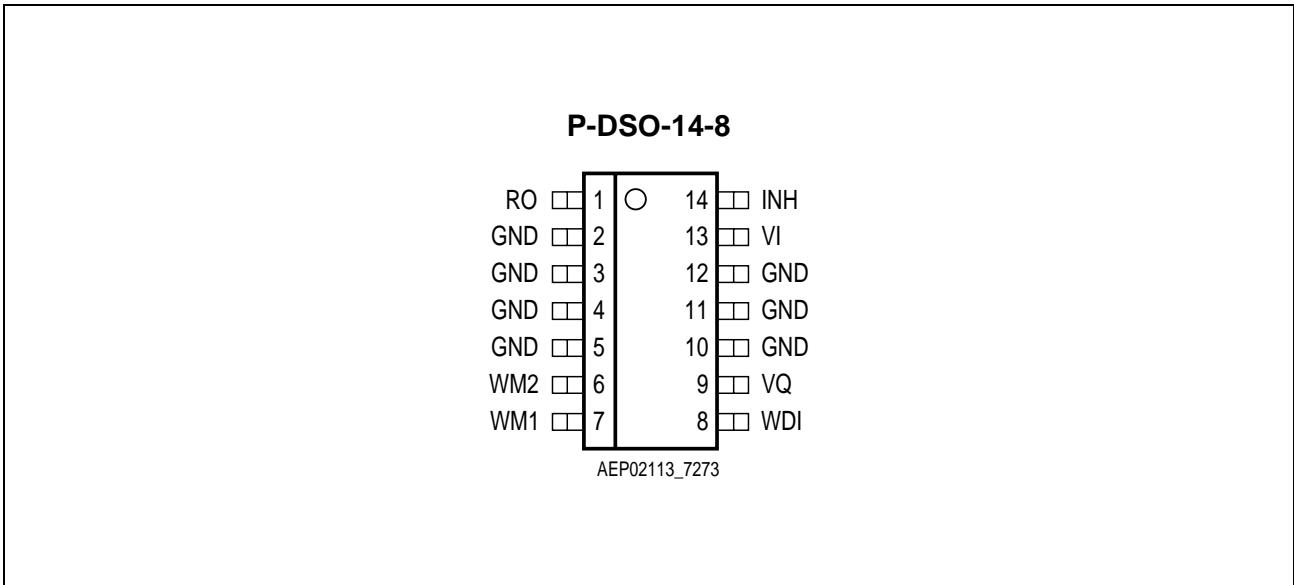
Due to its ultra low quiescent current, the TLE 7273 is perfectly suited for applications that are permanently connected to battery. In addition, the regulator can be shut down via the Inhibit input causing the current consumption to drop below 3  $\mu\text{A}$ . The TLE 7273 is equipped with protection functions against overload, short circuit and overtemperature. It operates in the wide junction temperature range from -40 °C to 150 °C.

**Derivatives market with “\*” have “Target” Status, others have “Final” Status**

Type	Ordering Code	Package
TLE 7273 GV50	SP000067155	P-DSO-14-8
* TLE 7273 GV33	Q67006-A9686	P-DSO-14-8
* TLE 7273 GV26	Q67006-A9685	P-DSO-14-8



**Figure 1 Block Diagram**



**Figure 2** Pin Configuration (top view)

**Table 1** Pin Definitions and Functions

Pin No.	Symbol	Function
1	RO	<b>Reset Output;</b> open drain output (TLE 7273 GV33, TLE 7273 GV26). Integrated 20 kΩ pull-up resistor (TLE 7273 GV50). Leave open if not needed.
2-5, 10-12	GND	<b>Ground;</b> Pin 2 and 3 must be connected to GND, Pin 4-5, 10-12 should be connected to PCB heat sink area on GND potential.
7	WM1	<b>Watchdog Mode Bit 1;</b> Watchdog and Reset mode selection, see <b>Figure 5.</b> Connect to $V_Q$ or GND.
6	WM2	<b>Watchdog Mode Bit 2;</b> Watchdog and Reset mode selection, see <b>Figure 5.</b> Connect to $V_Q$ or GND.
8	WDI	<b>Watchdog Input;</b> Trigger Input for Watchdog pulses. Pull down to GND if not needed and turn off the Watchdog with WM1 and WM2 pin.
9	$V_Q$	<b>Output voltage;</b> block to GND with a ceramic capacitor $C_Q \geq 470 \text{ nF}$ close to IC terminal.
13	$V_I$	<b>Input voltage;</b> block to ground directly at the IC with a 100 nF ceramic capacitor
14	INH	<b>Inhibit Input;</b> low level disables the IC. Integrated pull-down resistor.

**Table 2      Absolute Maximum Ratings**
 $-40^{\circ}\text{C} < T_{\text{j}} < 150^{\circ}\text{C}$ 

<b>Parameter</b>	<b>Symbol</b>	<b>Limit Values</b>		<b>Unit</b>	<b>Remarks</b>
		<b>Min.</b>	<b>Max.</b>		
<b>Input VI</b>					
Voltage	$V_{\text{I}}$	-0.3	45	V	-
Current	$I_{\text{I}}$	-	-	mA	Internally limited
<b>Output VQ</b>					
Voltage	$V_{\text{Q}}$	-0.3	5.5	V	Permanent
Voltage	$V_{\text{Q}}$	-0.3	6.2	V	$t < 10 \text{ s}^{1)}$
Current	$I_{\text{Q1}}$	-	-	mA	Internally limited
<b>Inhibit Input INH</b>					
Voltage	$V_{\overline{\text{INH}}}$	-1	45	V	-
Current	$I_{\overline{\text{INH}}}$	-1	1	mA	-
<b>Reset Output RO</b>					
Voltage	$V_{\text{RO}}$	-0.3	5.5	V	Permanent
Voltage	$V_{\text{RO}}$	-0.3	6.2	V	$t < 10 \text{ s}^{1)}$
Current	$I_{\text{RO}}$	-	-	mA	Internally limited
<b>Watchdog Input WDI</b>					
Voltage	$V_{\text{RO}}$	-1	7	V	Permanent
Current	$I_{\text{RO}}$	-	-	mA	Internally limited
<b>Watchdog Mode 1</b>					
Voltage	$V_{\text{WM1}}$	-0.3	5.5	V	Permanent
Voltage	$V_{\text{WM1}}$	-0.3	6.2	V	$t < 10 \text{ s}^{1)}$
Current	$I_{\text{WM1}}$	-5	5	mA	-
<b>Watchdog Mode 2</b>					
Voltage	$V_{\text{WM2}}$	-0.3	5.5	V	Permanent
Voltage	$V_{\text{WM2}}$	-0.3	6.2	V	$t < 10 \text{ s}^{1)}$
Current	$I_{\text{WM2}}$	-	-	mA	Internally limited

**Table 2      Absolute Maximum Ratings (cont'd)**
 $-40 \text{ }^{\circ}\text{C} < T_j < 150 \text{ }^{\circ}\text{C}$ 

<b>Parameter</b>	<b>Symbol</b>	<b>Limit Values</b>		<b>Unit</b>	<b>Remarks</b>
		<b>Min.</b>	<b>Max.</b>		

**ESD Susceptibility**

Human Body Model (HBM) <sup>2)</sup>	Class Voltage	-	2 3	- kV	-
Charged Device Model (CDM) <sup>3)</sup>	Class Voltage	-	F6 1.5	- kV	-

**Temperatures**

Junction temperature	$T_j$	-40	150	$^{\circ}\text{C}$	-
Storage temperature	$T_{\text{stg}}$	-50	150	$^{\circ}\text{C}$	-

1) Exposure to these absolute maximum ratings for extended periods ( $t > 10 \text{ s}$ ) may affect device reliability.

2) ESD HBM Test according JEDEC JESD22-A114

3) ESD CDM Test according JEDEC JESD22\_C101

*Note: Maximum ratings are absolute ratings; exceeding any one of these values may cause irreversible damage to the integrated circuit. Integrated protection functions are designed to prevent IC destruction under fault conditions. Fault conditions are considered as outside normal operating range. Protection functions are not designed for continuous repetitive operation.*

**Table 3      Operating Range**

<b>Parameter</b>	<b>Symbol</b>	<b>Limit Values</b>		<b>Unit</b>	<b>Remarks</b>
		<b>Min.</b>	<b>Max.</b>		
Input voltage	$V_I$	5.5	45	V	TLE 7273 GV50
		4.2	45	V	TLE 7273 GV33
		4.2	45	V	TLE 7273 GV26
Junction temperature	$T_j$	-40	150	°C	–

**Thermal Resistances P-DSO-14-8**

<b>Parameter</b>	<b>Symbol</b>	<b>Limit Values</b>		<b>Unit</b>	<b>Remarks</b>
		<b>typ..</b>	<b>max.</b>		
Junction pin	$R_{thj-pin}$	–	25	K/W	Measure to pin 4
Junction ambient	$R_{thj-a}$	130	–	K/W	PCB, only Footprint <sup>1)</sup>
Junction ambient	$R_{thj-a}$	90	–	K/W	PCB Heat Sink Area 300 mm <sup>2</sup> <sup>1)</sup>
Junction ambient	$R_{thj-a}$	80	–	K/W	PCB Heat Sink Area 600 mm <sup>2</sup> <sup>1)</sup>

1) Package mounted on PCB 80 × 80 × 1.5 mm<sup>3</sup>; 35µ Cu; 5µ Sn; zero airflow; 85 °C ambient temperature, horizontal PCB-position.

*Note: In the operating range the functions given in the circuit description are fulfilled.*

## Electrical Characteristics

$V_I = 13.5 \text{ V}$ ;  $-40^\circ\text{C} < T_j < 150^\circ\text{C}$ ; unless otherwise specified

<b>Parameter</b>	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		

### Output VQ

Output voltage	$V_Q$	4.90	5.00	5.10	V	TLE 7273 GV50 $1 \text{ mA} < I_Q < 180 \text{ mA}$ $6 \text{ V} < V_I < 16 \text{ V}$
Output voltage	$V_Q$	4.90	5.00	5.10	V	TLE 7273 GV50 $I_Q = 10 \text{ mA}$ $6 \text{ V} < V_I < 45 \text{ V}$
Output voltage	$V_Q$	3.234	3.30	3.366	V	TLE 7273 GV33 $1 \text{ mA} < I_Q < 180 \text{ mA}$ $4.5 \text{ V} < V_I < 16 \text{ V}$
Output voltage	$V_Q$	3.234	3.30	3.366	V	TLE 7273 GV33 $I_Q = 10 \text{ mA}$ $4.5 \text{ V} < V_I < 45 \text{ V}$
Output voltage	$V_Q$	2.548	2.60	2.652	V	TLE 7273 GV26 $1 \text{ mA} < I_Q < 180 \text{ mA}$ $4.5 \text{ V} < V_I < 16 \text{ V}$
Output voltage	$V_Q$	2.548	2.60	2.652	V	TLE 7273 GV26 $I_Q = 10 \text{ mA}$ $4.5 \text{ V} < V_I < 45 \text{ V}$
Output current limitation	$I_Q$	200	—	500	mA	$V_Q = 2.0 \text{ V}$
		200	—	600		$V_Q = 0 \text{ V}$
Output drop voltage; $V_{DR} = V_I - V_Q$	$V_{DR}$	—	250	500	mV	<sup>1)</sup> $I_Q = 180 \text{ mA}$ only TLE7273GV50
Load regulation	$\Delta V_{Q,Lo}$	—	50	90	mV	$1 \text{ mA} < I_Q < 180 \text{ mA};$
Line regulation	$\Delta V_{Q,Li}$	—	10	50	mV	$I_Q = 1 \text{ mA};$ $10 \text{ V} < V_I < 32 \text{ V}$
Power-Supply-Ripple-Rejection	$PSRR$	—	60	—	dB	$f_r = 100 \text{ Hz};$ $V_r = 0.5 V_{PP}$
Reverse Output Current Protection	$V_Q$	—	—	5.5	V	$I_Q = -1 \text{ mA},$ $V_{INH} = 0 \text{ V}$

## Electrical Characteristics (cont'd)

$V_I = 13.5 \text{ V}$ ;  $-40^\circ\text{C} < T_j < 150^\circ\text{C}$ ; unless otherwise specified

<b>Parameter</b>	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		

## Current Consumption

Quiescent current; $I_q = I_I - I_Q$	$I_q$	—	—	35	$\mu\text{A}$	$I_Q = 100 \mu\text{A}$ ; $T_j < 80^\circ\text{C}$
Quiescent current; inhibited	$I_q$	—	1	3	$\mu\text{A}$	$V_{INH} = 0 \text{ V}; T_j < 80^\circ\text{C}$

## Inhibit Input $\overline{INH}$

Turn-on Voltage High Signal valid	$V_{\overline{INH}\text{ ON}}$	3.0	—	—	V	$V_Q$ on
Turn-off Voltage Low Signal valid	$V_{\overline{INH}\text{ OFF}}$	—	—	0.4	V	$V_Q = 0.02 \text{ V}$ at $I_Q = 5 \text{ mA}$
H-input current	$I_{\overline{INH}\text{ ON}}$	—	3	4	$\mu\text{A}$	$V_{\overline{INH}} = 5 \text{ V}$
L-input current	$I_{\overline{INH}\text{ OFF}}$	—	0.5	1	$\mu\text{A}$	$V_{\overline{INH}} = 0 \text{ V}, T_j < 80^\circ\text{C}$

## Watchdog Mode Bit 1

Threshold High Level High Signal valid	$V_{WM1,H}$	4.00	—	—	V	TLE 7273 GV50
		2.65	—	—	V	TLE 7273 GV33
		2.30	—	—	V	TLE 7273 GV26
Threshold Low Level Low Signal valid	$V_{WM1,L}$	—	—	0.80	V	

## Watchdog Mode Bit 2

Threshold High Level High Signal valid	$V_{WM2,H}$	4.00	—	—	V	TLE 7273 GV50
		2.65	—	—	V	TLE 7273 GV33
		2.30	—	—	V	TLE 7273 GV26
Threshold Low Level Low Signal valid	$V_{WM2,L}$	—	—	0.80	V	

## Electrical Characteristics (cont'd)

$V_I = 13.5 \text{ V}$ ;  $-40^\circ\text{C} < T_j < 150^\circ\text{C}$ ; unless otherwise specified

<b>Parameter</b>	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		

## Watchdog Input WDI

H-input voltage threshold High Signal valid	$V_{WDIH}$	4.00 2.65 2.30	— — —	— — —	V	TLE 7273 GV50 TLE 7273 GV33 TLE 7273 GV26
L-input voltage threshold Low Signal valid	$V_{WDIL}$	—	—	0.80	V	
H-input current	$I_{WDIH}$	—	3	4	$\mu\text{A}$	$V_{WDI} = 5 \text{ V}$
L-input current	$I_{WDIL}$	—	0.5	1	$\mu\text{A}$	$V_{WDI} = 0 \text{ V}, T_j < 80^\circ\text{C}$
Watchdog sampling time	$t_{\text{sam}}$	0.40 0.80	0.50 1.00	0.60 1.20	ms	Fast watchdog timing Slow watchdog timing
Ignore window time	$t_{IW}$	25.6 51.2	32.0 64.0	38.4 76.8	ms	Fast watchdog timing Slow watchdog timing
Open window time	$t_{OW}$	25.6 51.2	32.0 64.0	38.4 76.8	ms	Fast watchdog timing Slow watchdog timing
Closed window time	$t_{CW}$	25.6 51.2	32.0 64.0	38.4 76.8	ms	Fast watchdog timing Slow watchdog timing
Window watchdog trigger time <sup>2)</sup>	$t_{WD}$	— —	48 96	— —	ms	Fast watchdog timing Slow watchdog timing
Watchdog deactivation current threshold	$I_{Q,WD\_off}$	0.50	1.50	5	mA	$I_Q$ decreasing $V_I > 5.5\text{V}$ for TLE 7273 GV50 $V_I > 4.2\text{V}$ for TLE 7273 GV33, TLE 7273 GV26

## Electrical Characteristics (cont'd)

$V_I = 13.5 \text{ V}$ ;  $-40^\circ\text{C} < T_j < 150^\circ\text{C}$ ; unless otherwise specified

<b>Parameter</b>	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
Watchdog activating current threshold	$I_{Q,WD\_on}$	0.50	1.70	5	mA	$I_Q$ increasing $V_I > 5.5\text{V}$ for TLE 7273 GV50 $V_I > 4.2\text{V}$ for TLE 7273 GV33, TLE 7273 GV26

## Reset Output RO

Output Voltage Reset Switching Threshold	$V_{RT}$	4.50	4.60	4.70	V	TLE 7273 GV50 $V_Q$ decreasing
		3.00	3.07	3.13	V	TLE 7273 GV33 <sup>3)</sup> $V_I > 4.2\text{V}$ , $V_Q$ decreasing
		2.35	2.38	2.45	V	TLE 7273 GV26 <sup>3)</sup> $V_I > 4.2\text{V}$ , $V_Q$ decreasing
Input Voltage Reset Switching Threshold	$V_{RT\_VI}$	—	3.9	4.0	V	TLE 7273 GV26 <sup>3)</sup> TLE 7273 GV33 <sup>3)</sup> $V_Q > V_{RT}$ , $V_I$ decreasing
Output Voltage Reset Hysteresis	$V_{RH}$	—	45	—	mV	TLE 7273 GV26
		—	60	—	mV	TLE 7273 GV33
		—	90	—	mV	TLE 7273 GV50
Reset sink current	$I_{RO}$	1.75	—	—	mA	TLE 7273 GV50 $V_Q = 4.5\text{V}$ , $V_{RO} = 0.25\text{V}$
		1.30	—	—	mA	TLE 7273 GV33 $V_Q = 3.0\text{V}$ , $V_{RO} = 0.25\text{V}$
		1.10	—	—	mA	TLE 7273 GV26 $V_Q = 2.35\text{V}$ , $V_{RO} = 0.25\text{V}$
Reset output low voltage	$V_{ROL}$	—	0.15	0.25	V	$V_Q \geq 1 \text{ V}$ ; $I_{RO} < 200 \mu\text{A}$
Reset high voltage	$V_{ROH}$	4.5	—	—	V	TLE 7273 GV50
Reset high leakage current	$I_{ROLK}$	—	—	1	$\mu\text{A}$	TLE 7273 GV33 TLE 7273 GV26

## Electrical Characteristics (cont'd)

$V_I = 13.5 \text{ V}$ ;  $-40^\circ\text{C} < T_j < 150^\circ\text{C}$ ; unless otherwise specified

<b>Parameter</b>	<b>Symbol</b>	<b>Limit Values</b>			<b>Unit</b>	<b>Test Condition</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>		
Integrated reset pull up resistor	$R_{RO}$	10	20	40	kΩ	TLE 7273 GV50 Internally connected to $V_Q$
Power-on Reset delay time	$T_{RD}$	12.8	16.0	19.2	ms	Fast reset timing
		25.6	32.0	38.4	ms	Slow reset timing
Reset Reaction Time	$T_{RR}$	-	4	12	μs	

- 1) measured when the output voltage has dropped 100 mV from the nominal Value obtained at  $V_I = 13.5 \text{ V}$ .
- 2) Recommendation for typical trigger time.  $t_{WD} = t_{CW} + 1/2 * t_{OW}$
- 3) Reset Output triggered when Output Voltage  $V_Q$  is lower than Output Voltage Reset Switching Threshold  $V_{RT}$  or is also triggered, when Input Voltage is decreasing to  $V_I < 4.0 \text{ V}$  and  $V_Q > V_{RT}$

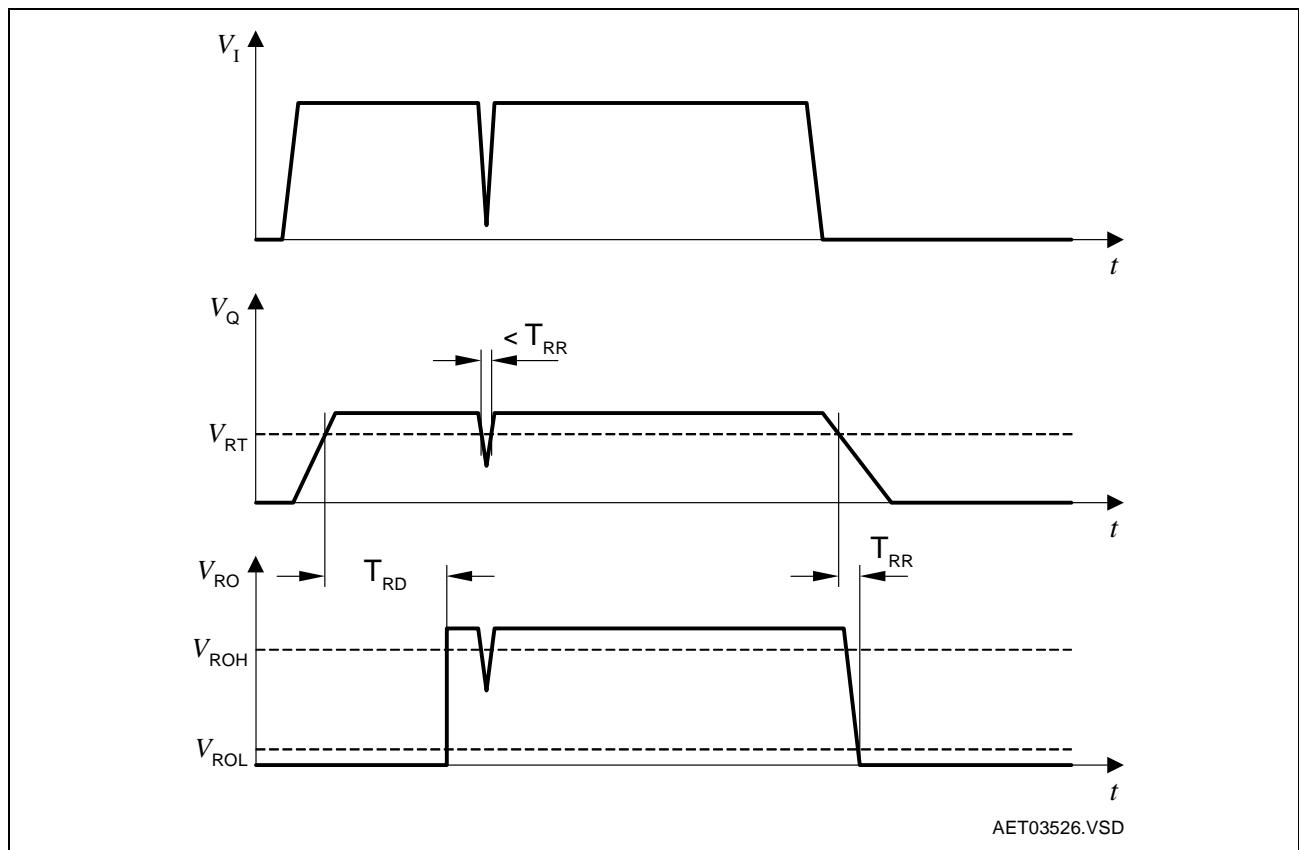
## Circuit Description

### Power On Reset and Reset Output

For an output voltage level of  $V_Q \geq 1$  V, the reset output is held low. When the level of  $V_Q$  reaches the reset threshold  $V_{RT}$ , the signal at RO remains low for the power-up reset delay time  $T_{RD}$ . The reset function and timing is illustrated in **Figure 3**. The reset reaction time  $T_{RR}$  avoids wrong triggering caused by short “glitches” on the  $V_Q$ -line. In case of  $V_Q$  power down ( $V_Q < V_{RT}$  for  $t > T_{RR}$ ) a logic low signal is generated at the pin RO to reset an external microcontroller.

The TLE 7273 GV50 features an integrated pull-up resistor on the reset output while the TLE 7273 GV33 and TLE 7273 GV26 have an open drain output requiring an external pull-up resistor  $\geq 5.6$  k $\Omega$ <sup>1)</sup>. At low output voltage levels  $V_Q < 1$  V the integrated pull-up resistor of the TLE 7273 GV50 is switched off setting the reset output high ohmic. Example: Calculation based on the reset sink current and an external pull-up resistor connection to 5V:

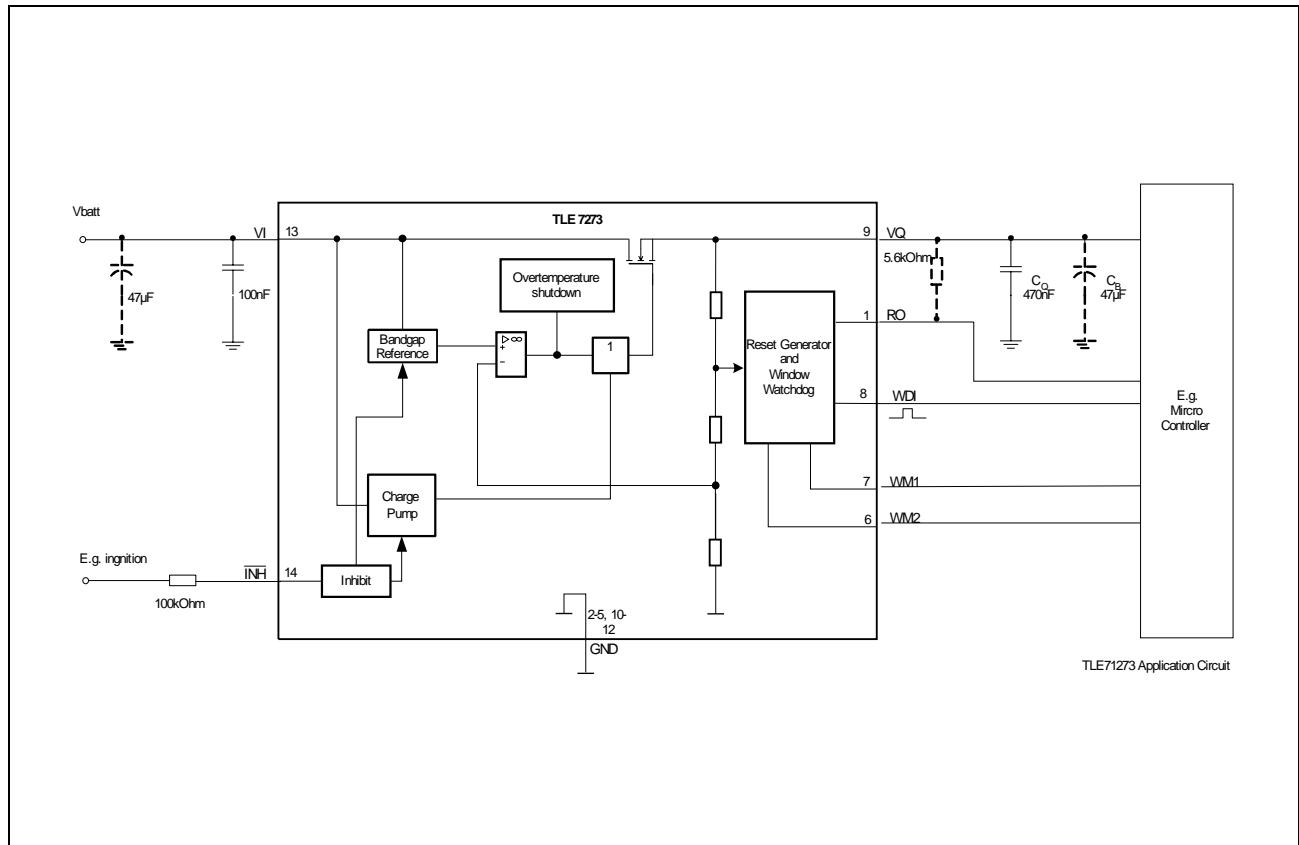
$$R_{extmin} = dU / I_{RO} = (V_{RTmin} - V_{ROmin}) / I_{RO} = (4.5V - 0.25V) / 1.75mA = 2.42k\Omega$$



**Figure 3      Reset Function and Timing Diagram**

1) Referred to pull-up voltage level of 5 V.

## Application Circuit



**Figure 4 Application Diagram**

A typical application of the TLE 7273 is shown in Fig.4. To prevent the regulation loop from oscillating a ceramic capacitor  $\geq 470\text{nF}$  is required at the output  $V_Q$ . In contrast to most low drop voltage regulators, the TLE 7273 only needs moderate capacitance at the output and tolerates ceramic capacitors to keep the stability. This offers more design flexibility to the circuit designer enabling also to operate the device without tantalum capacitors.

Additionally, a blocking capacitor  $C_B$  of  $10 \dots 47 \mu\text{F}$  should be used for the output  $V_Q$  to suppress influences from load surges to the voltage levels. This one can either be an aluminum electrolytic capacitor or a tantalum capacitor following the application requirements.

A general recommendation at  $T_j < 90^\circ\text{C}$  is to keep the drop over the equivalent serial resistor (ESR) of the blocking capacitor  $C_B$  together with the discharge of the blocking capacitor below 300mV. Since the regulator output current roughly rises linearly with time the discharge of the capacitor can be calculated as:

$$dV_{C_B} = dI_Q * dt / C_B$$

The drop across the ESR calculates as:

$$\Delta V_{ESR} = \Delta I * ESR$$

To prevent a reset the following relationship must be fulfilled:

$$\Delta V_C + \Delta V_{ESR} < 300mV$$

Example: Assuming a load current step of  $\Delta I_Q = 50mA$ , a blocking capacitor of  $C_Q = 22\mu F$  and a typical regulator reaction time under normal operating conditions of  $dt \sim 25\mu s$  and for special dynamic load conditions, such as load step from very low base load, a reaction time of  $dt \sim 75\mu s$ .

For this example the typical condition is considered and the calculation is done based on  $dt = 25\mu s$ :

$$\Delta V_C = 0.1A * 25\mu s / 22\mu F = 114mV$$

So for the ESR we can allow

$$\Delta V_{ESR} = 300mV - 114mV = 186mV$$

The permissible ESR becomes:

$$ESR = 186mV / 100mA = 1.86\Omega$$

During design-in of the TLE7273 product family, special care needs to be taken with regards to the regulators reaction time on sudden load current changes starting from very low pre-load as well as cyclic load changes. The application note "*TLE7x Voltage Regulators - Application Note about Transient Response at ultra low quiescent current Voltage Regulators*" (see 3\_cip05405.pdf) gives important hints for successful design-in of the Voltage Regulators of the TLE7x family.

## Watchdog Operation

The watchdog uses a fraction of the charge pump oscillator's clock signal as timebase. The watchdog timebase can be adjusted using the pins WM1 and WM2 (see **Figure 5**). The watchdog can be turned off setting WM1 and WM2 to high level. The timing values refer to typ. values with WM1 and WM2 connected to GND (fast watchdog and reset timing).

**Figure 5** shows the state diagram of the window watchdog (WWD) and the watchdog and reset mode selection. After power-on, the reset output signal at the RO pin (microcontroller reset) is kept LOW for the reset delay time  $T_{RD}$  of typ. 16 ms. With the LOW to HIGH transition of the signal at RO the device starts the ignore window time  $t_{CW}$  (32 ms). During this window the signal at the WDI pin is ignored. Next the WWD starts the open window which is in the very first turn after power up a long open window with  $t_{max} = 4 * t_{OW}$ . In the following turns, the timing corresponds to the standard timing setting as described in the specification.

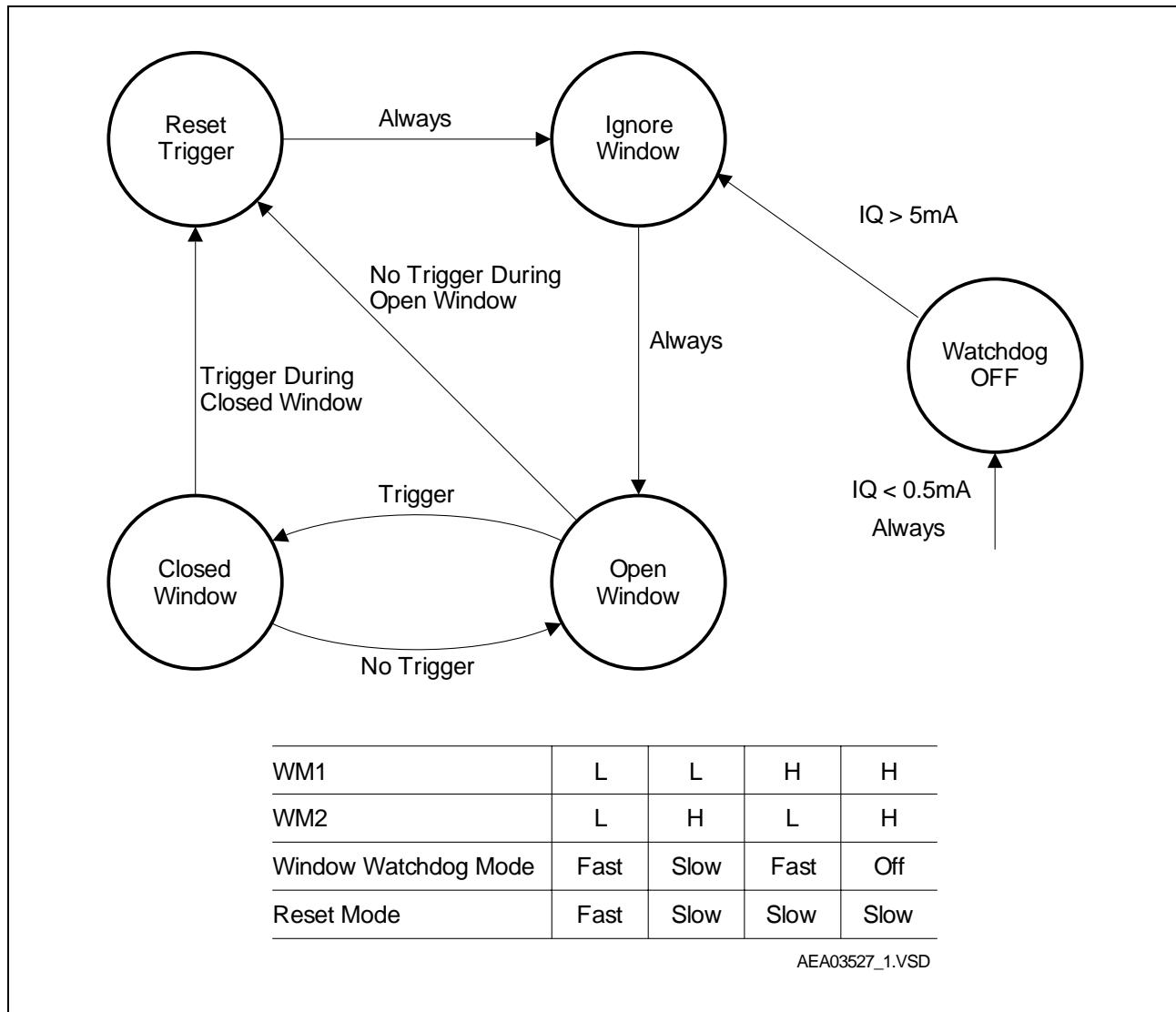
When a valid trigger signal is detected during the open window a closed window is initialized immediately. A trigger signal within the closed window is interpreted as a pretrigger failure and results in a reset. After the closed window the open window with the duration  $t_{OW}$  is started again. The open window lasts at minimum until the trigger process has occurred, at maximum  $t_{OW}$  is 32 ms (typ. value with fast timing).

A HIGH to LOW transition of the watchdog trigger signal at pin WDI is considered as a valid trigger pulse.

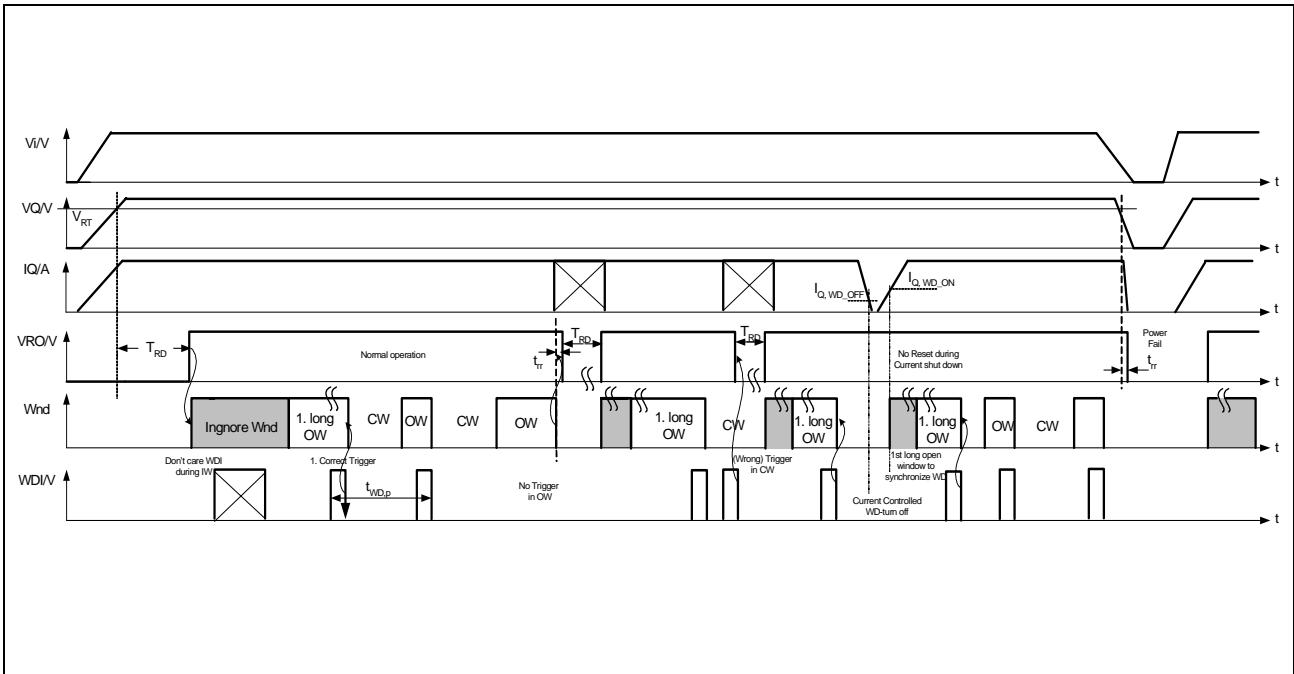
See **Figure 7**: To avoid wrong triggering due to parasitic glitches two HIGH samples followed by two LOW samples (sample period  $t_{sam}$  typ. 0.5 ms) are decoded as a valid trigger .

A reset is generated (RO goes LOW) if there is no trigger pulse during the open window or if a pretrigger occurs during the closed window. The triggering is correct also, if the first three samples (two HIGH one LOW) of the trigger pulse at pin WDI are inside the closed window and only the fourth sample (the second LOW sample) is taken in the open window.

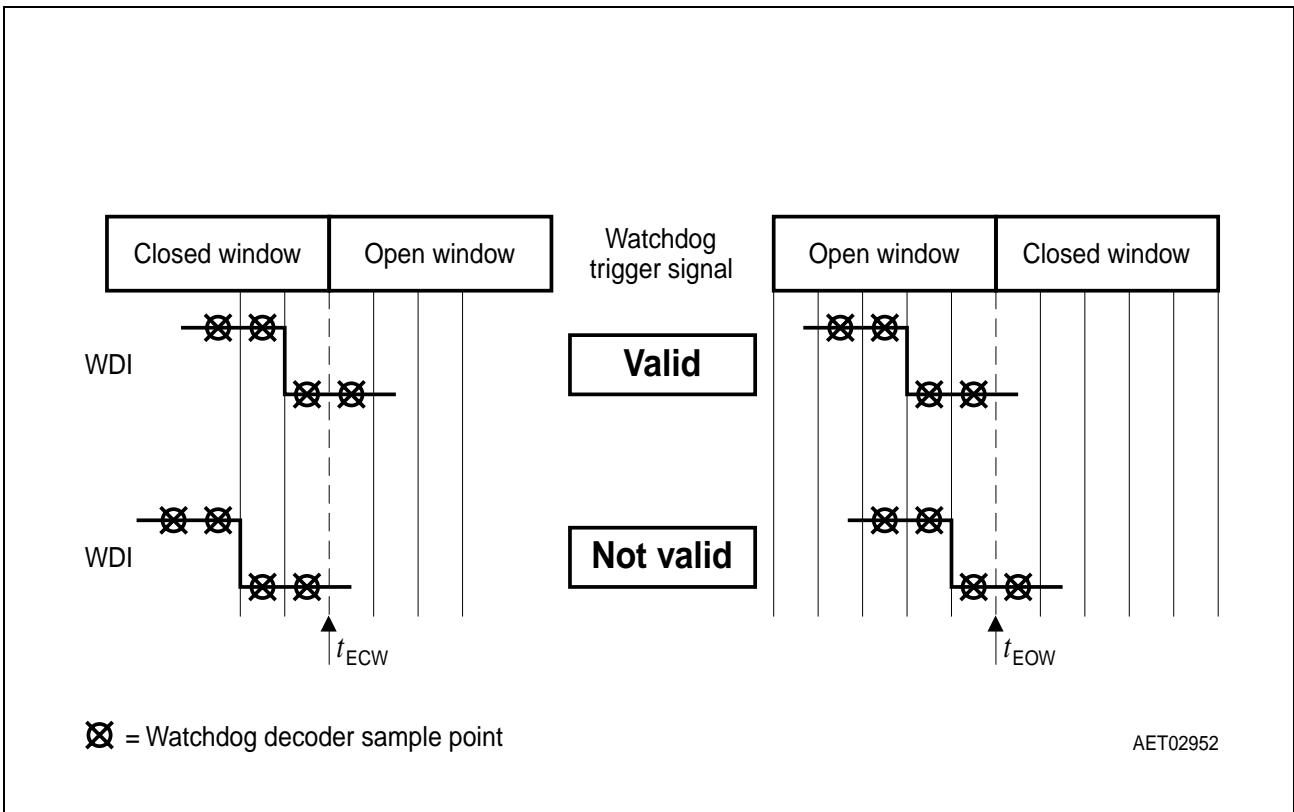
After turning OFF the Watchdog by output current reduction, RO remains high. (see also the signal diagram in **Figure 6**). After turning ON the WWD again by exceeding the current threshold, the logic cycle starts again with the Ignore Window and goes then into the "1st. long open window". This 1st long OW is maximum  $4 * t_{OW}$  long and allows the re-synchronisation between the micro controller and the WWD timing. The 1st. long OW is closed by the first valid trigger on WDI from the micro controller. This trigger ensures the synchronisation. As soon as this trigger is done, the micro controller timing must be stable and correspondent to  $t_{WD}$  .



**Figure 5      Window Watchdog State Diagram, Watchdog and Reset Modes**



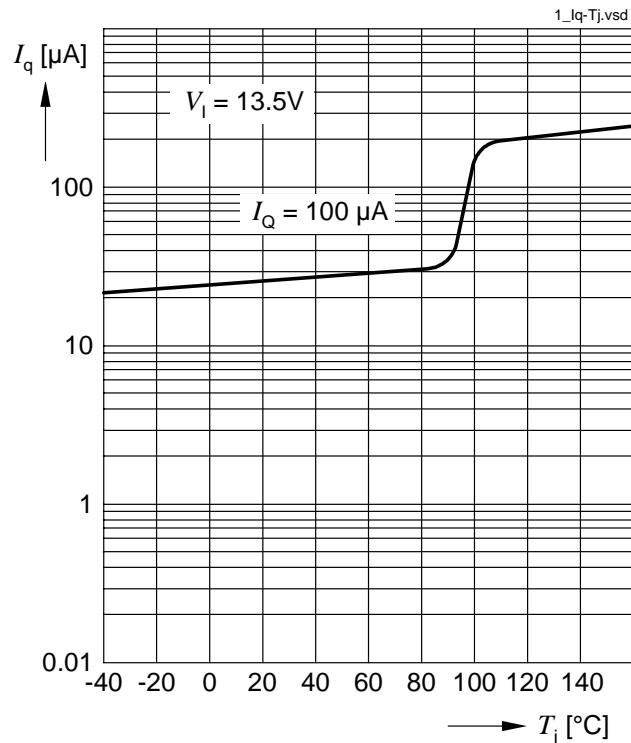
**Figure 6      Window Watchdog Signal Diagram**



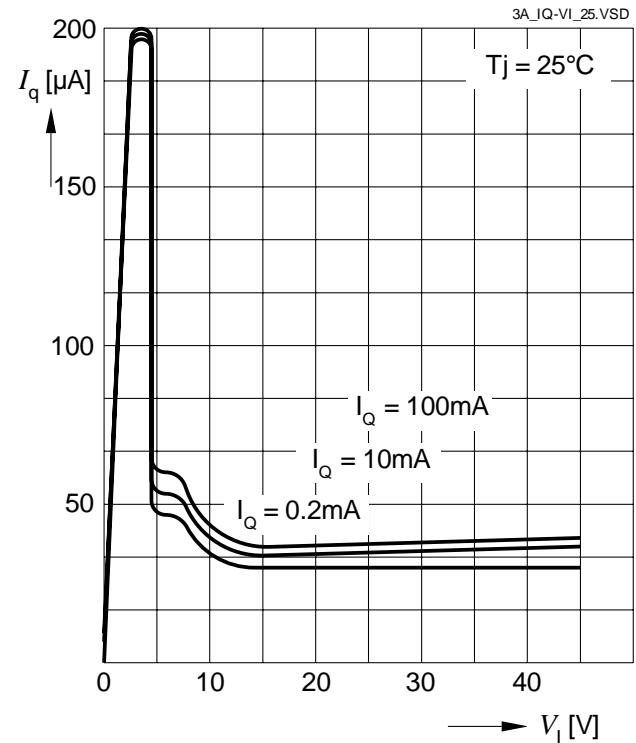
**Figure 7      Window Watchdog Definitions**

## Typical Performance Characteristics

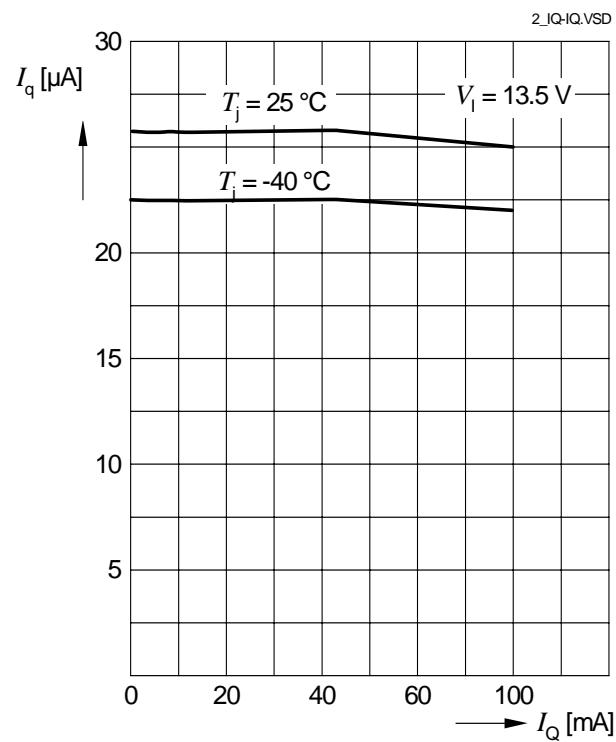
**Current Consumption  $I_q$  versus Junction Temperature  $T_j$  (INH=ON)**



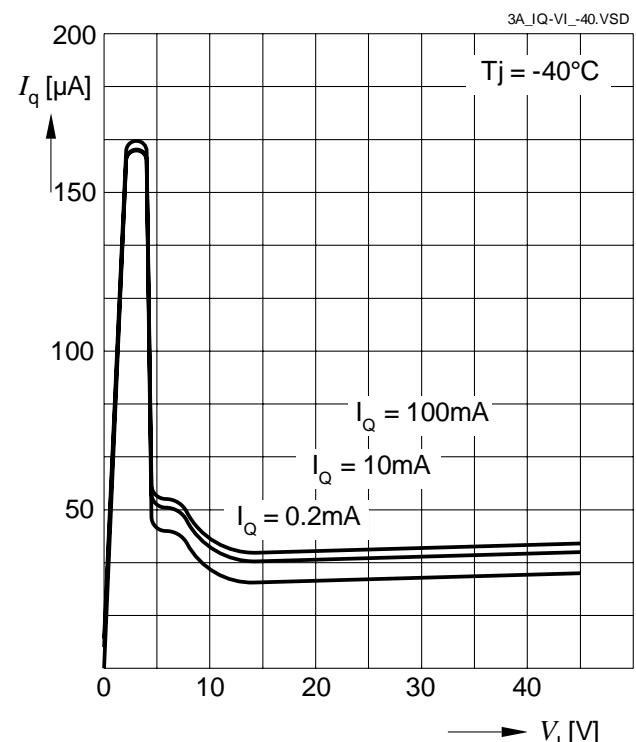
**Current Consumption  $I_q$  versus Input Voltage  $V_l$  at  $T_j=25^\circ\text{C}$  (INH=ON)**

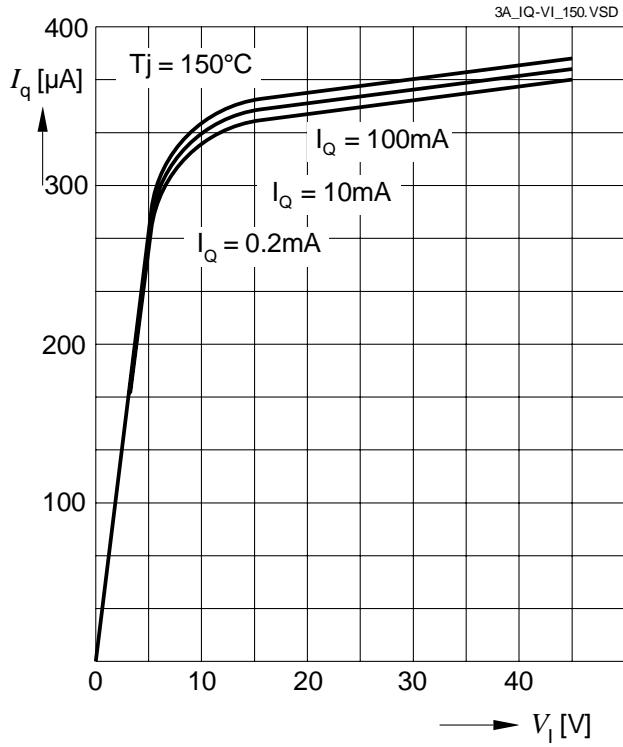
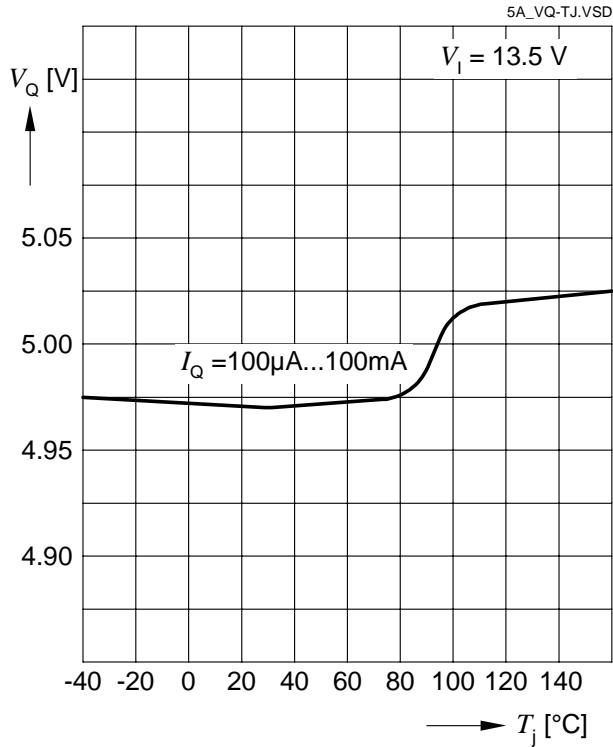
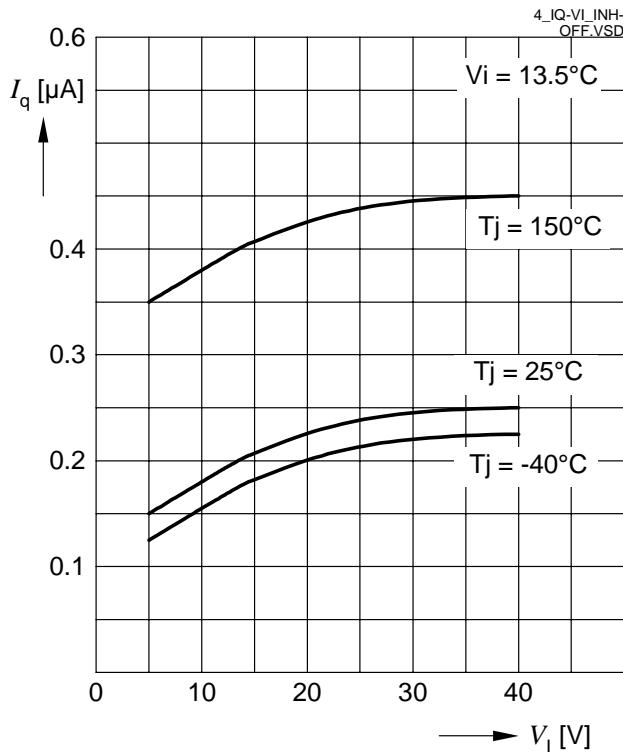
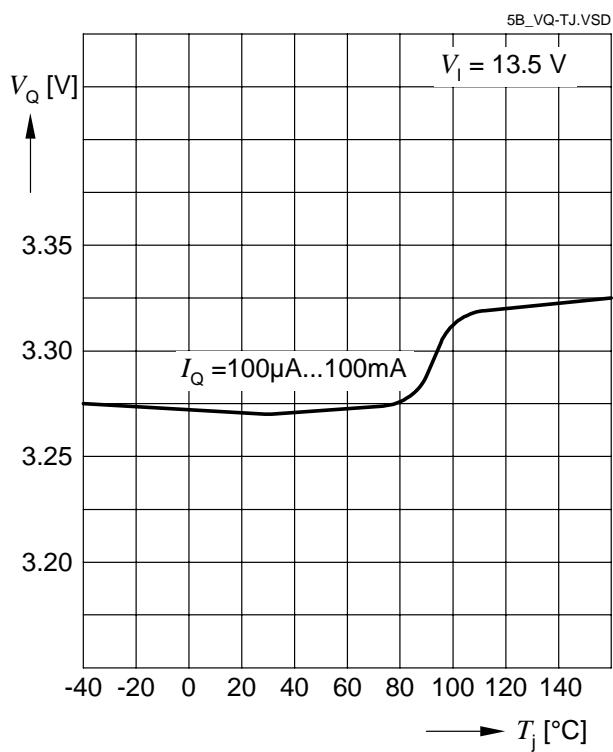


**Current Consumption  $I_q$  versus Output Current  $I_Q$  (INH=ON)**

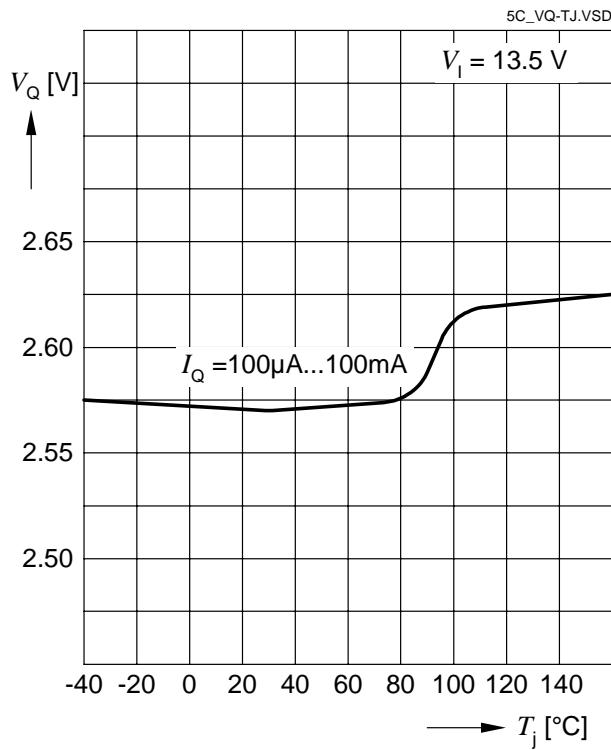


**Current Consumption  $I_q$  versus Input Voltage  $V_l$  at  $T_j=-40^\circ\text{C}$  (INH=ON)**

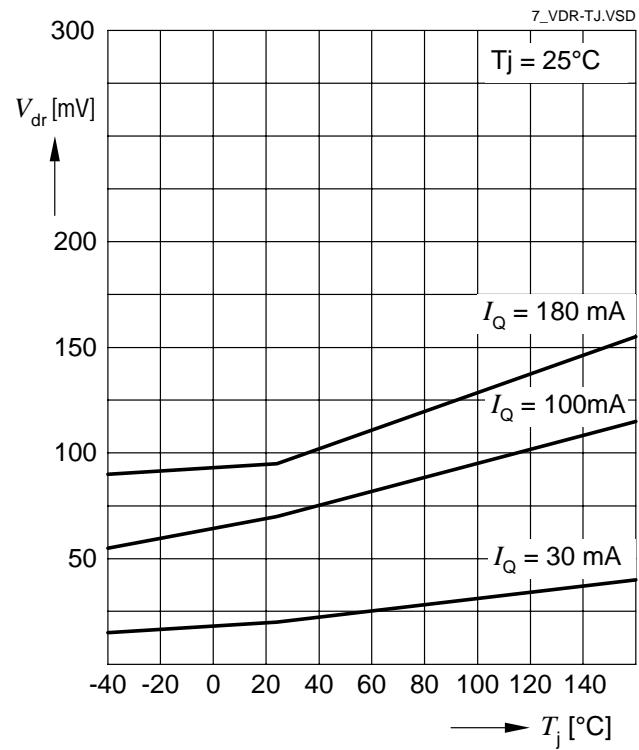


**Current Consumption  $I_q$  versus Input Voltage  $V_i$  at  $T_j=150^\circ\text{C}$  (INH=ON)**

**Output Voltage  $V_Q$  versus Junction Temperature  $T_j$  (5V Version)**

**Current Consumption  $I_q$  versus Input Voltage  $V_i$  at  $T_j=150^\circ\text{C}$  (INH=OFF)**

**Output Voltage  $V_Q$  versus Junction Temperature  $T_j$  (3.3V Version)**


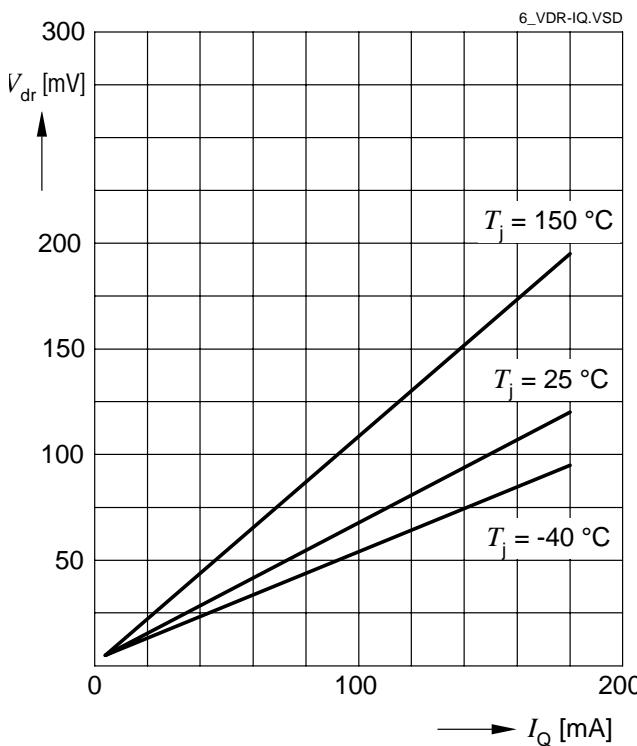
### Output Voltage $V_Q$ versus Junction Temperature $T_j$ (2.6V Version)



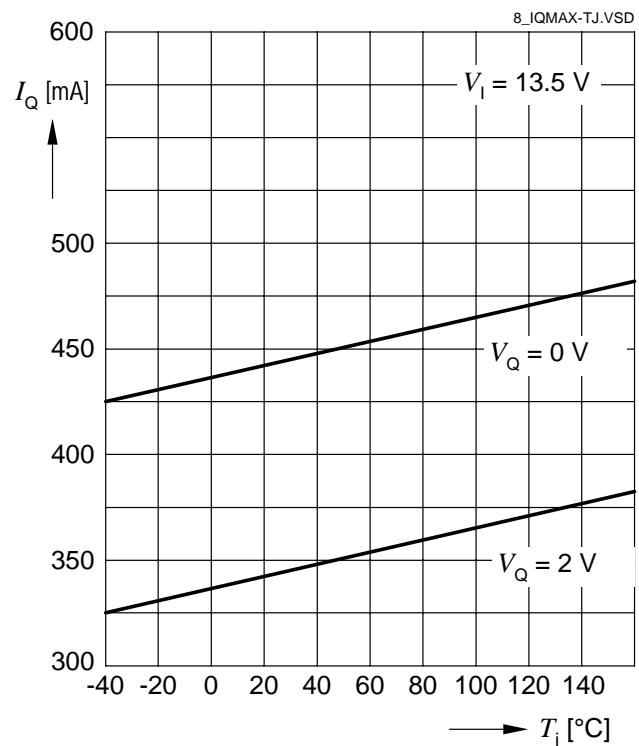
### Dropout Voltage $V_{dr}$ versus Junction Temperature $T_j$



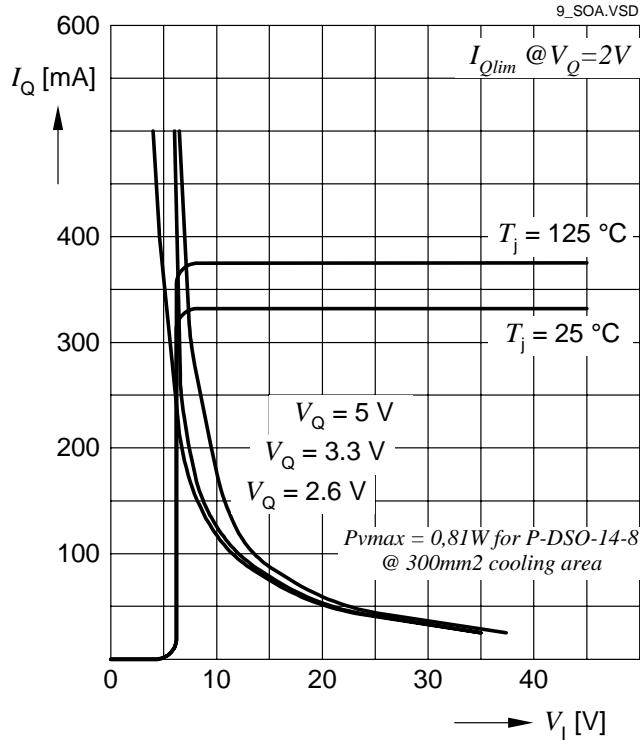
### Dropout Voltage $V_{dr}$ versus Output Current $I_Q$



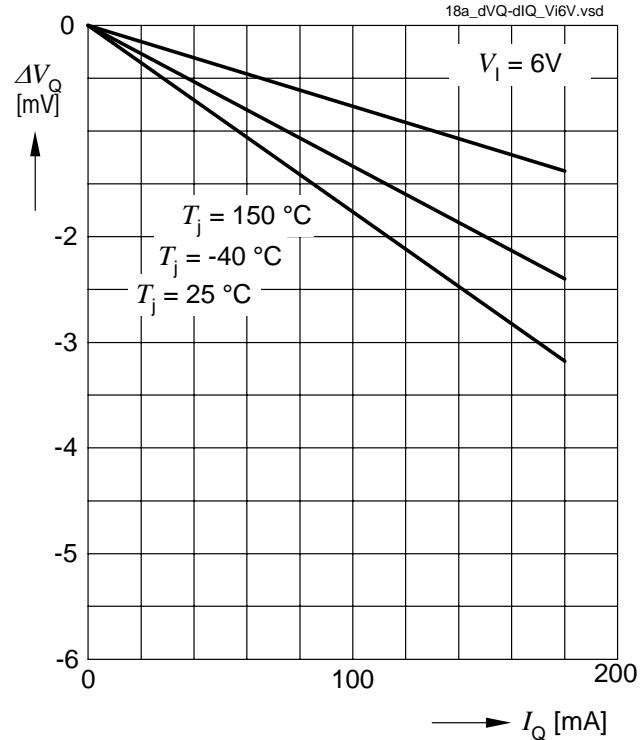
### Maximum Output Current $I_Q$ versus Junction Temperature $T_j$



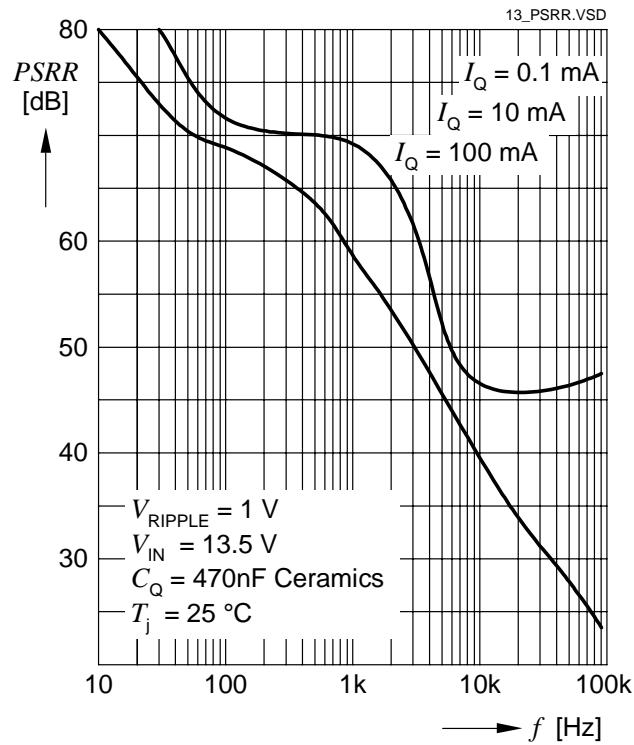
### Maximum Output Current $I_Q$ versus Input Voltage $V_I$



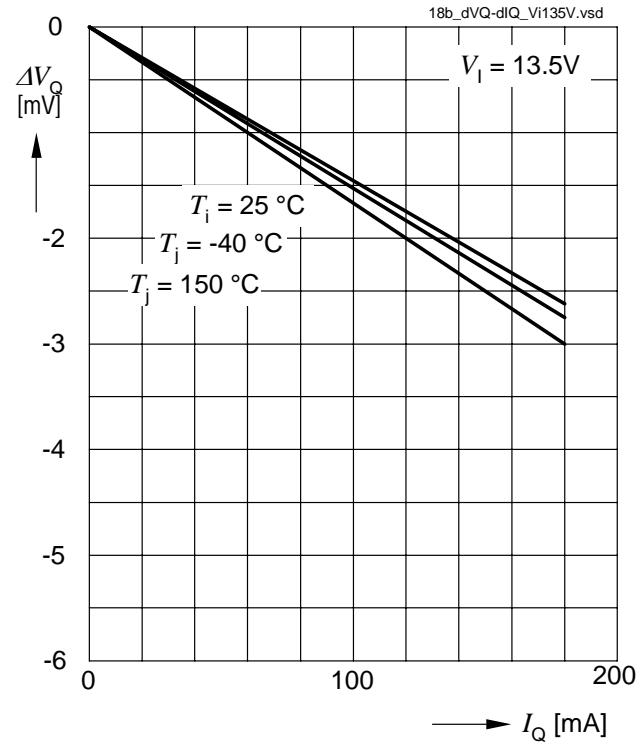
### Load Regulation $\Delta V_Q$ versus Output Current Change $dI_Q$



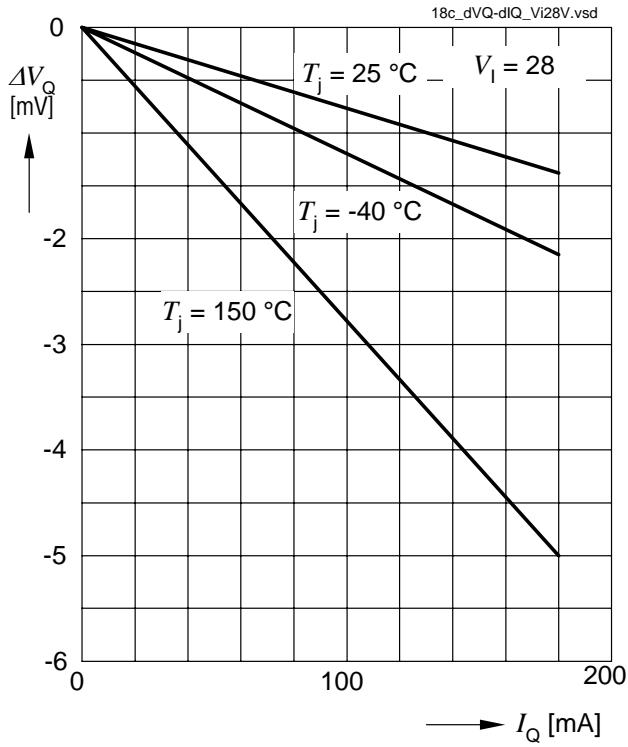
### Power Supply Ripple Rejection PSRR



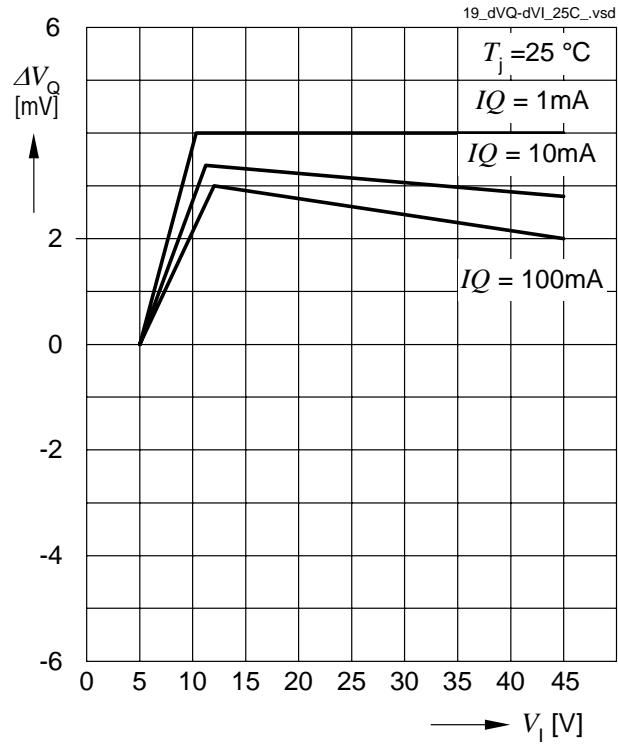
### Load Regulation $\Delta V_Q$ versus Output Current Change $dI_Q$



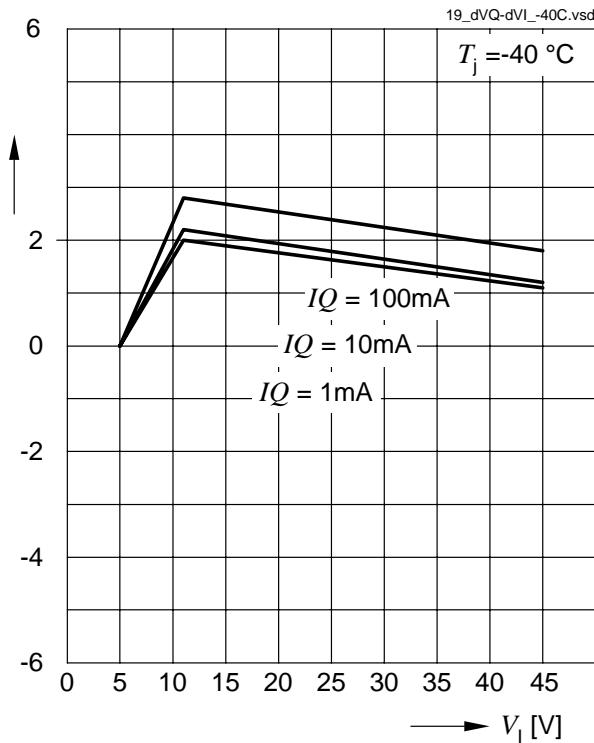
### Load Regulation $\Delta V_Q$ versus Output Current Change $dI_Q$



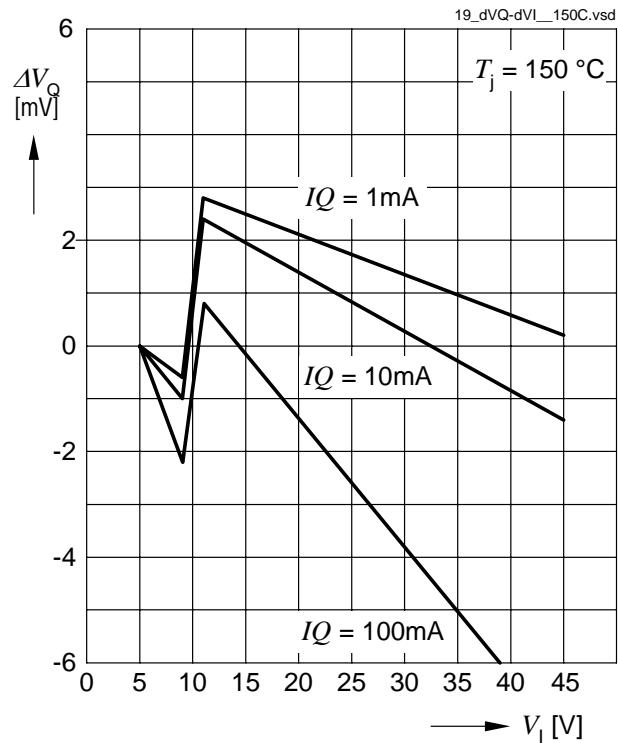
### Line Regulation $\Delta V_Q$ versus Input Voltage Change $dV_I$



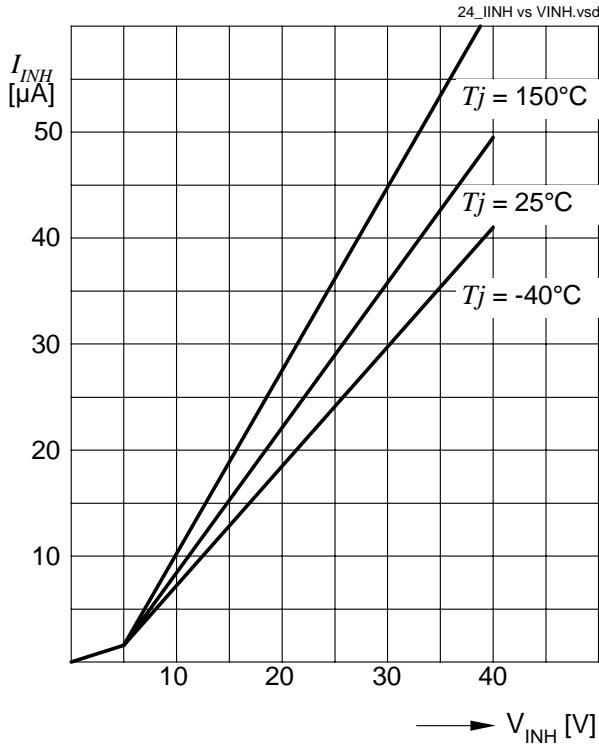
### Line Regulation $\Delta V_Q$ versus Input Voltage Change $dV_I$



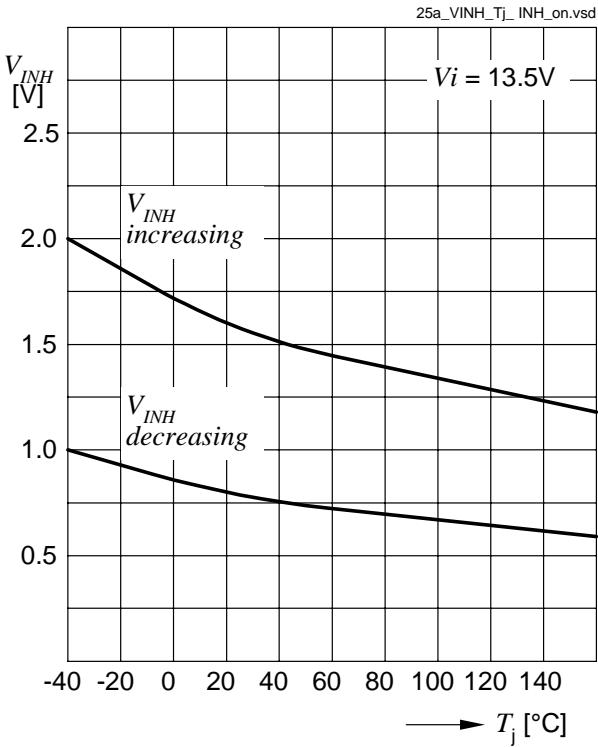
### Line Regulation $\Delta V_Q$ versus Input Voltage Change $dV_I$



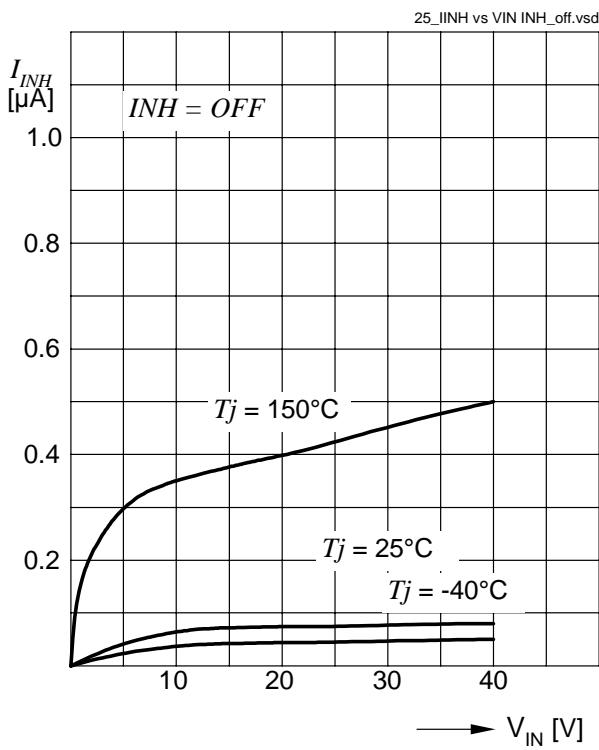
### Inhibit Input Current $I_{INH}$ versus Inhibit Input Voltage $V_{INH}$



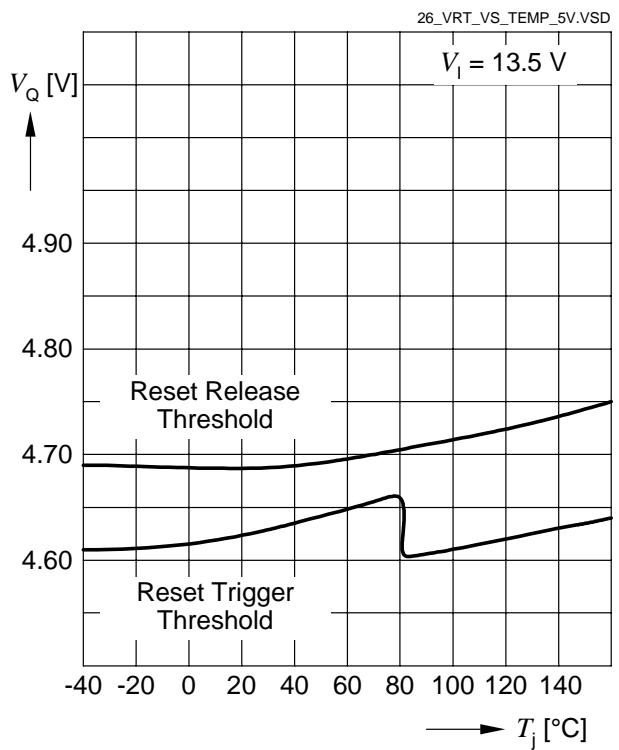
### Inhibit Turn-ON/OFF Threshold $V_{INH\_ON}$ versus Junction Temperature $T_j$



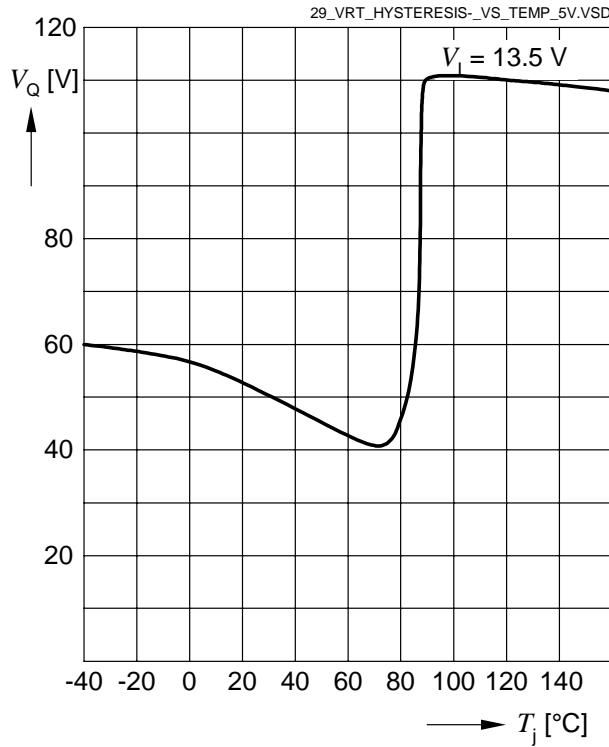
### Inhibit Input Current $I_{INH}$ versus Input Voltage $V_i$ , INH=Off



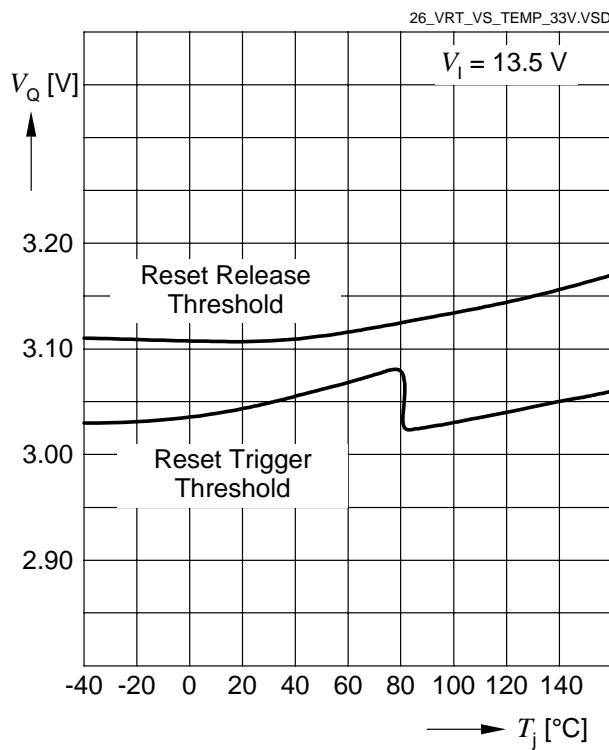
### Reset Threshold $V_{RT}$ versus Junction Temperature $T_j$ (5V-Version)



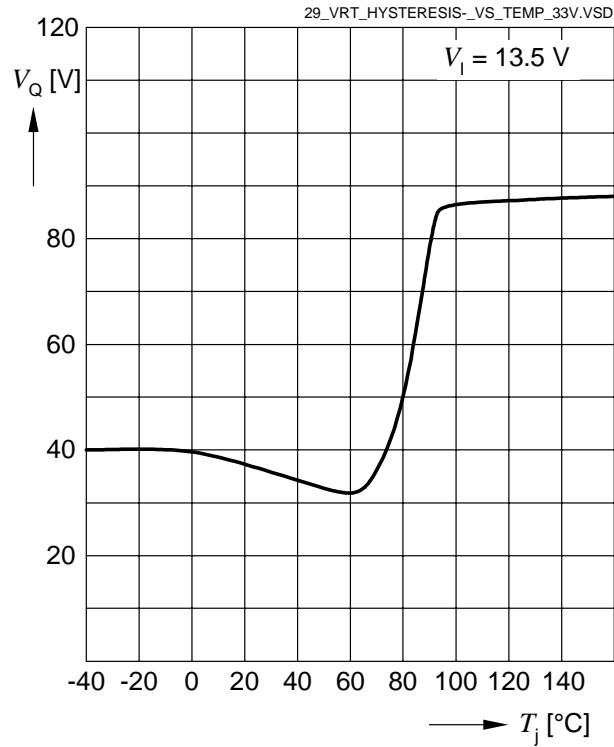
### Reset Hysteresis versus Junction Temperature $T_j$ (5V-Version)



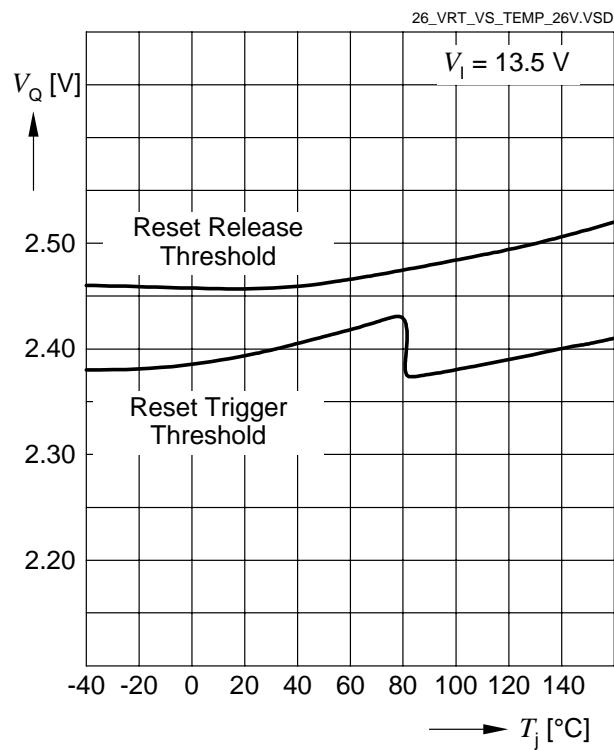
### Reset Threshold $V_{RT}$ versus Junction Temperature $T_j$ (3.3V-Version)



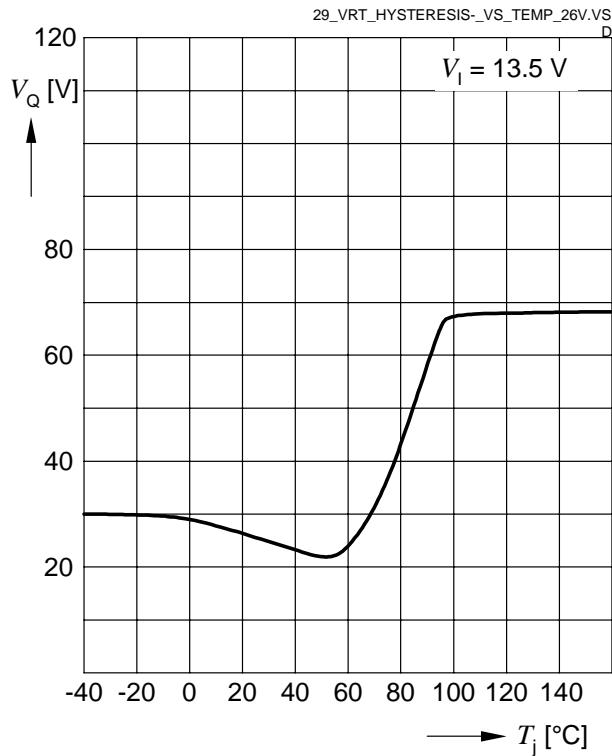
### Reset Hysteresis versus Junction Temperature $T_j$ (3.3V-Version)



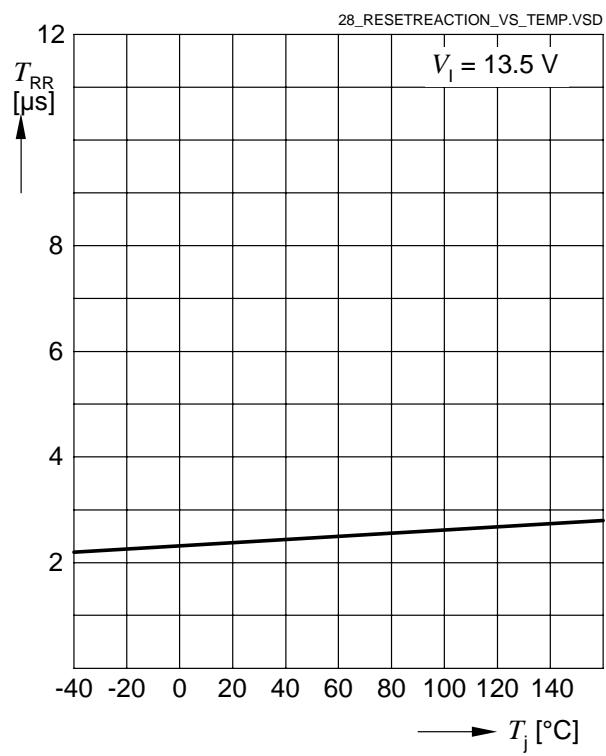
### Reset Threshold $V_{RT}$ versus Junction Temperature $T_j$ (2.6V-Version)



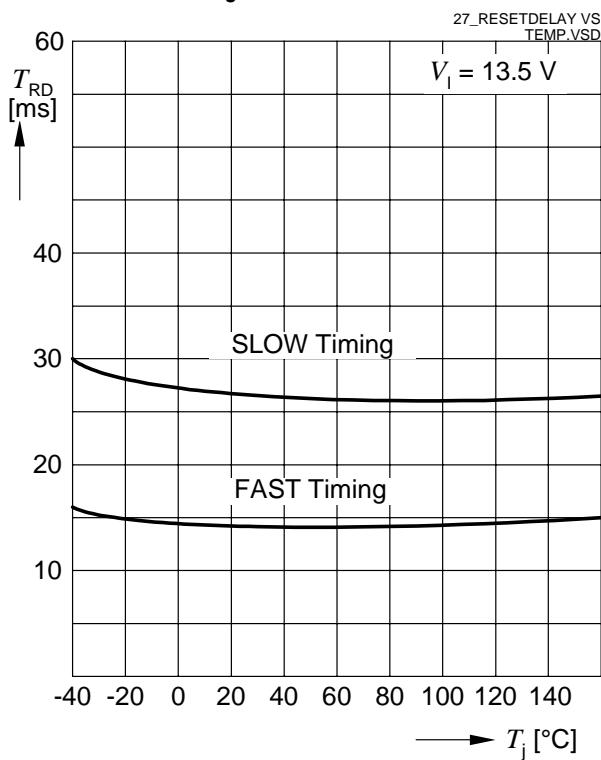
### Reset Hysteresis versus Junction Temperature $T_j$ (2.6V-Version)



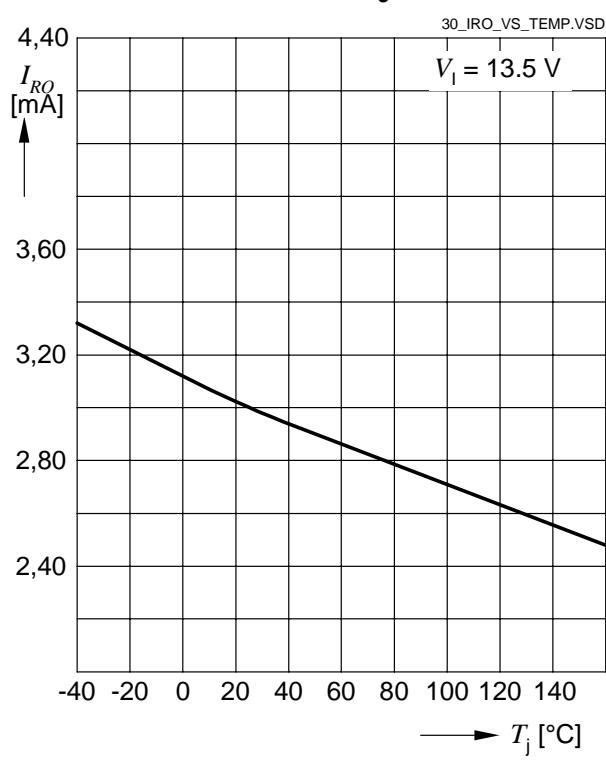
### Reset Reaction Time $T_{rr}$ versus Junction Temperature $T_j$



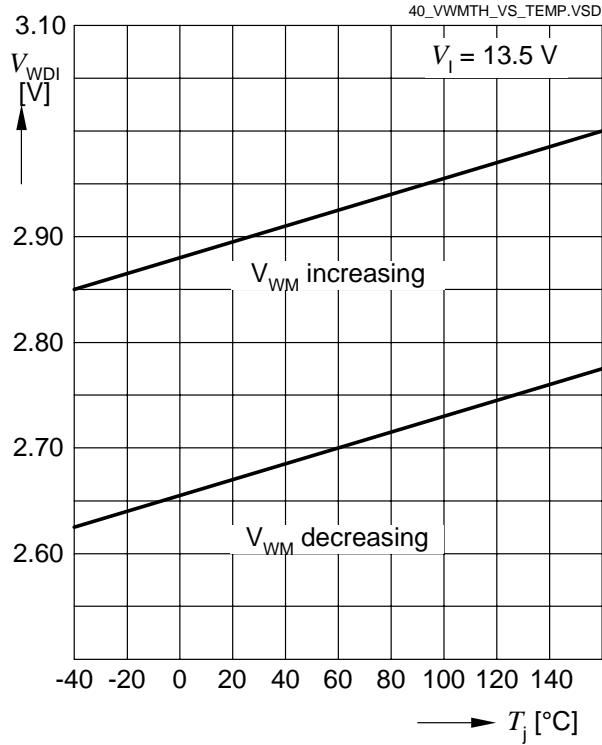
### Reset Delay $T_{RD}$ Time versus Junction Temperature $T_j$



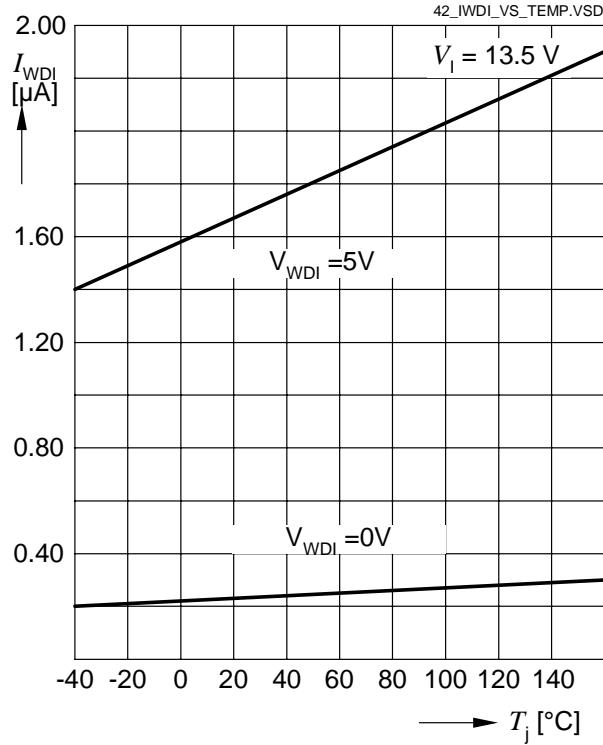
### Reset Output Sink Current $I_{RO}$ versus Junction Temperature $T_j$



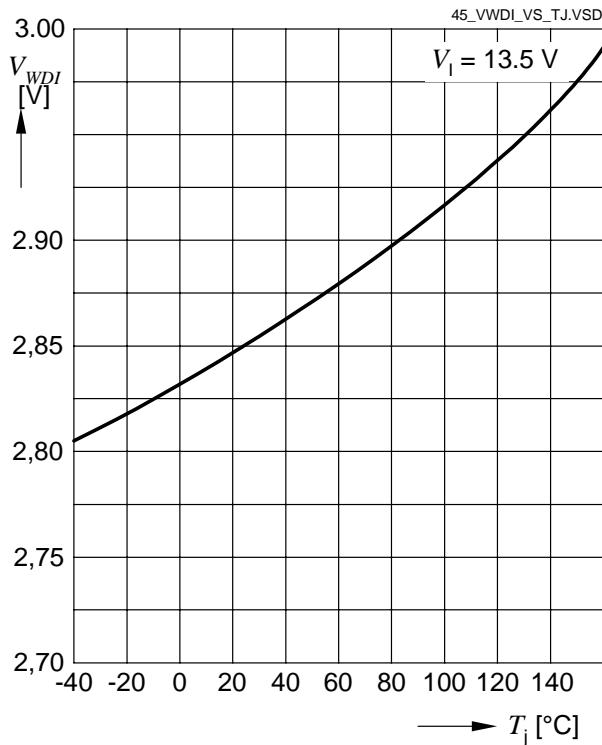
### Watchdog Mode Bit Threshold $V_{WM}$ versus Junction Temperature $T_j$



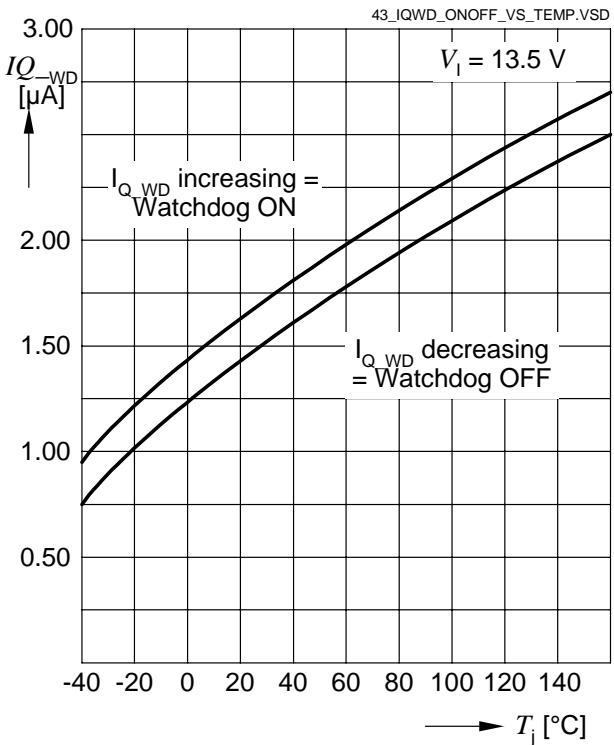
### Watchdog Input Current $I_{WDI}$ versus Junction Temperature $T_j$



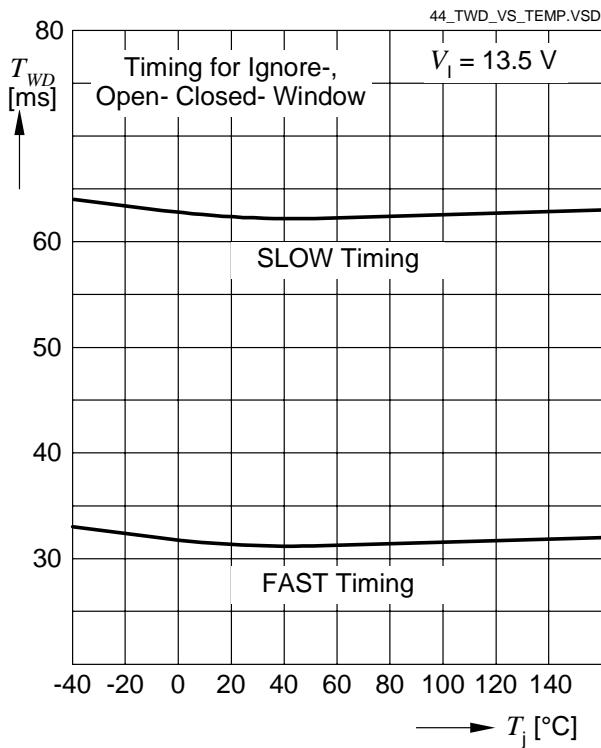
### Watchdog Input Threshold $V_{WDI}$ versus Junction Temperature $T_j$



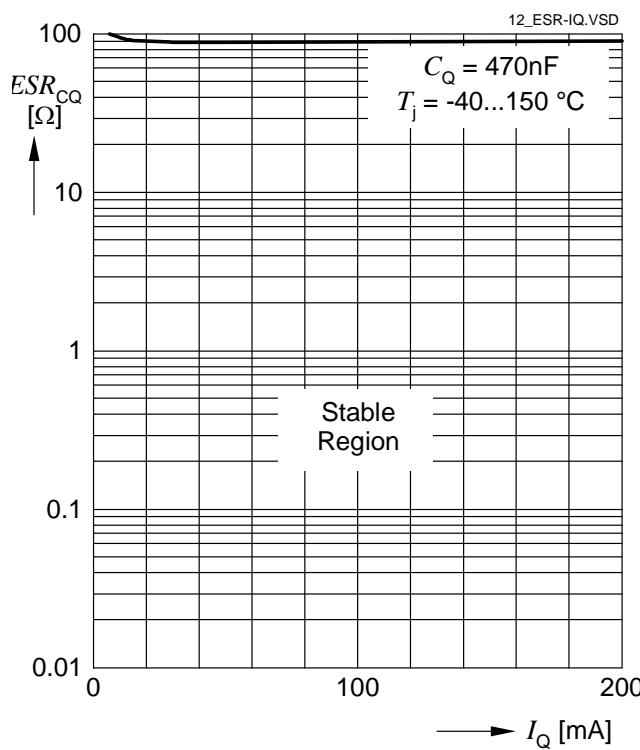
### Watchdog Deactivation Current $I_{Q\_WD}$ versus Junction Temperature $T_j$



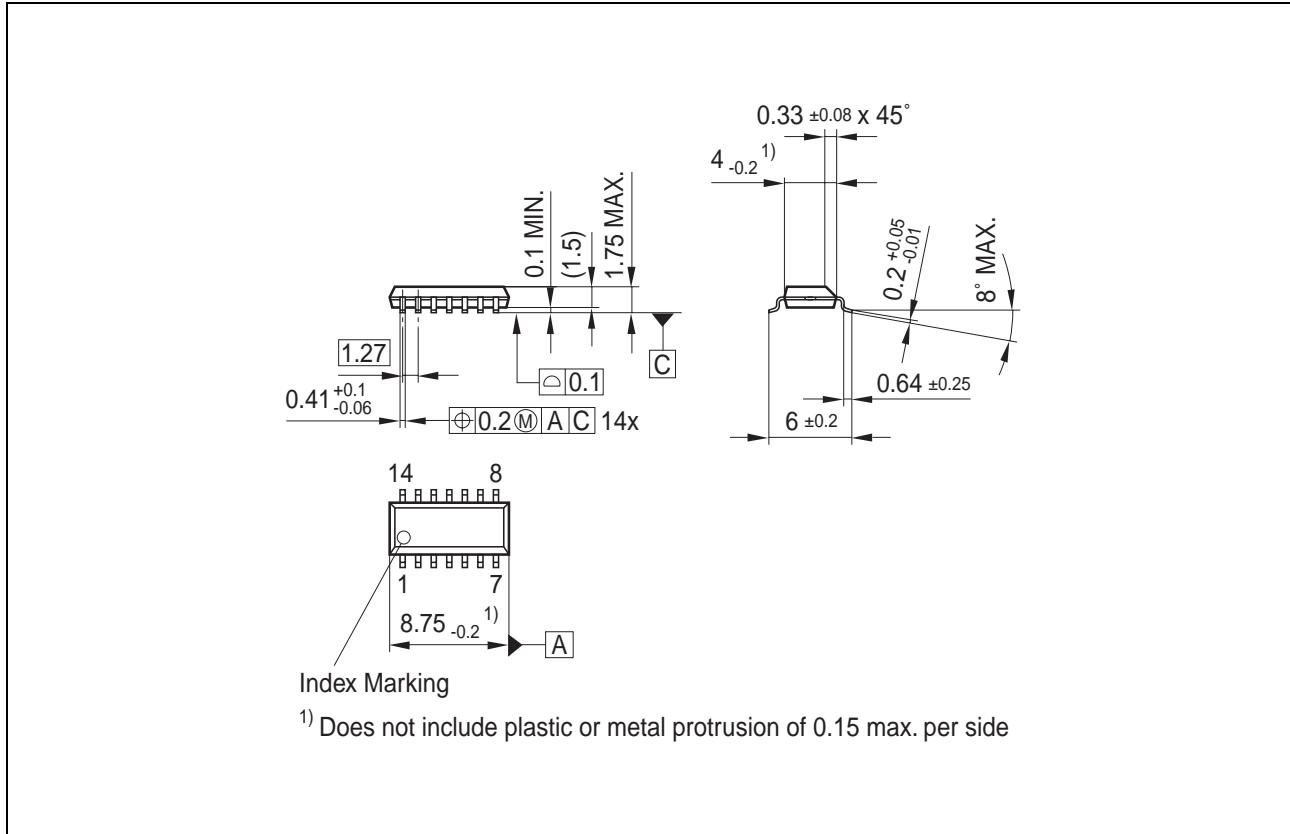
## Watchdog Timing $T_{WD}$ versus Junction Temperature $T_j$



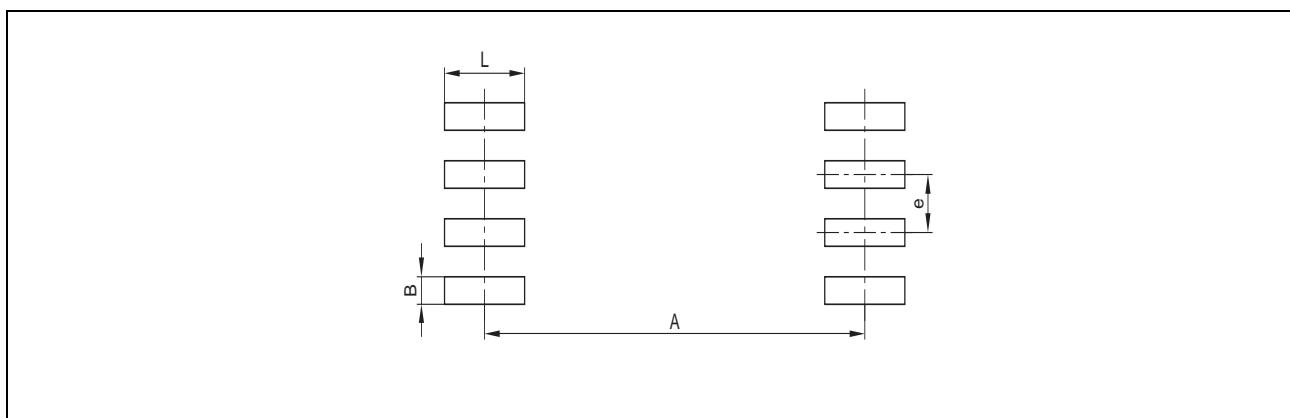
## Region of Stability



## Package Outlines



**Figure 1      Package Drawing P-DSO-14-8**



**Figure 2      Foot Print for P-DSO-14-8**  
 $e=1.27 \text{ mm}$ ;  $A=5.69 \text{ mm}$ ;  $L=1.31 \text{ mm}$ ;  $B=0.65 \text{ mm}$

## **Remarks**

**Edition 2005-11-30**

**Published by Infineon Technologies AG,  
St.-Martin-Strasse 53,  
81669 München, Germany**

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